



Tracking 2

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Santa Barbara
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Review and Outline

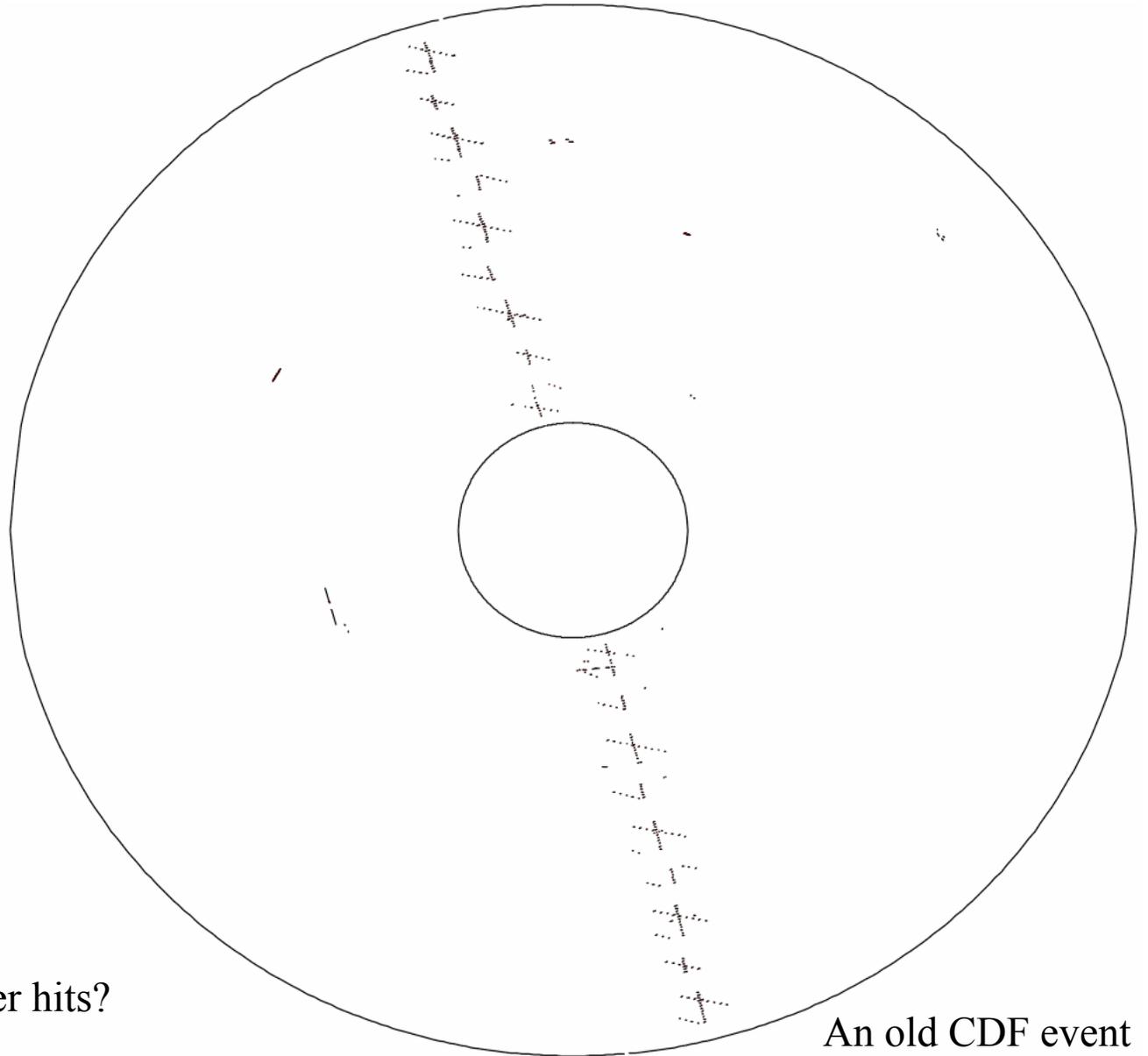
- Goals of tracking
 - Measure 4-vector and origin of particles.
 - Confirm and improve from other components
- Hardware
 - Measure position (“hits”) at points along path.
 - $dE/dx \Rightarrow$ ionization \Rightarrow position
- Software
 - Collect measured hits and fit a helix.

Track Finding (AKA Tracking)

- Pattern recognition
- Fitting
- Performance assessment

Pattern recognition

Find the track(s).



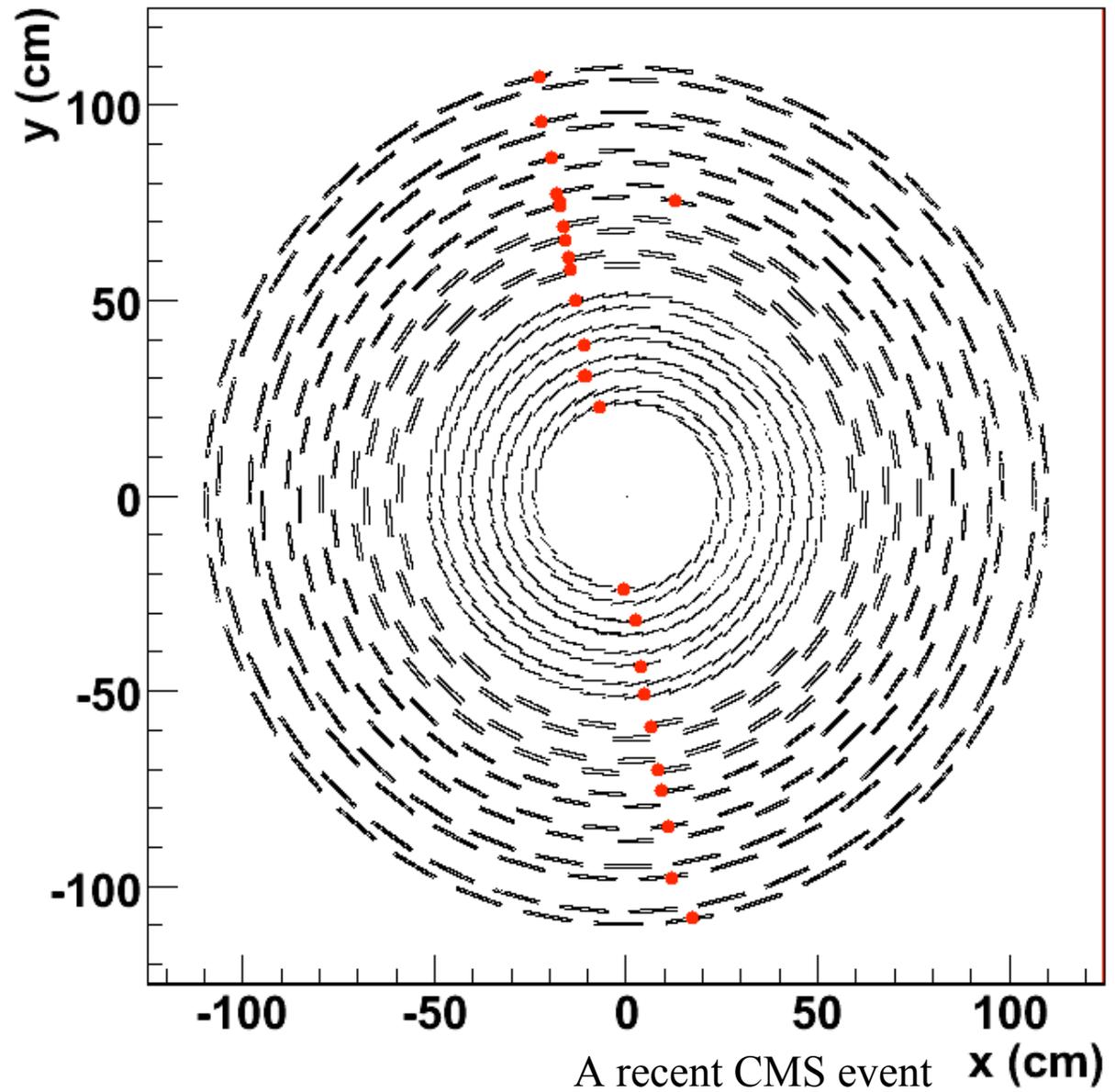
Check: What causes the other hits?

An old CDF event

Pattern recognition

Find the track(s).

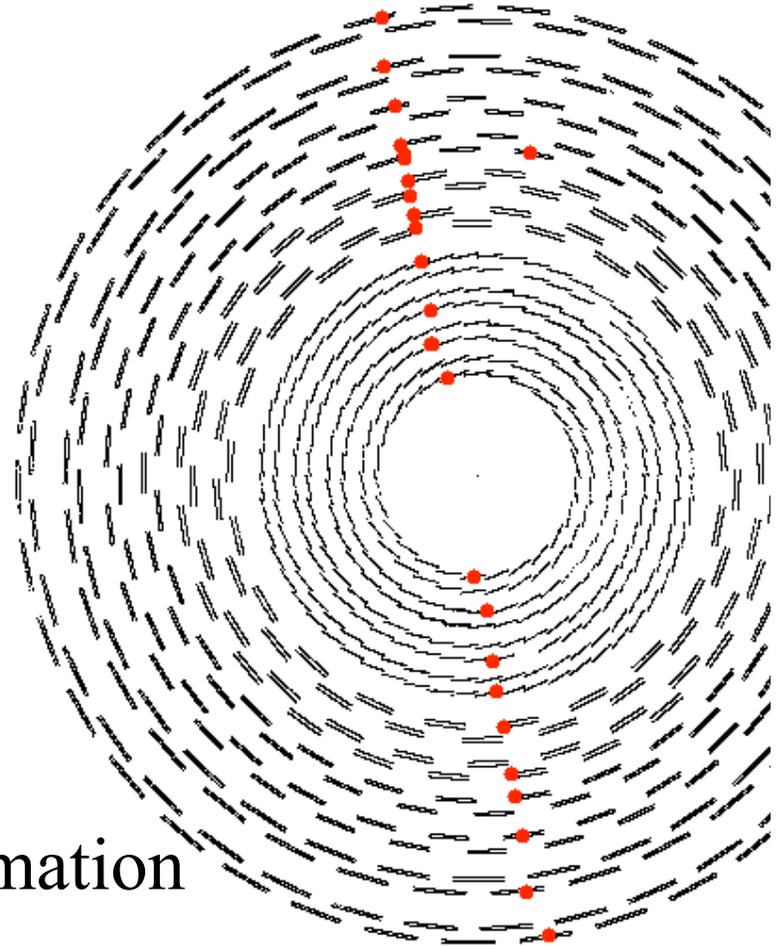
Pretty easy. How to code it?



Pattern recognition

Three approaches:

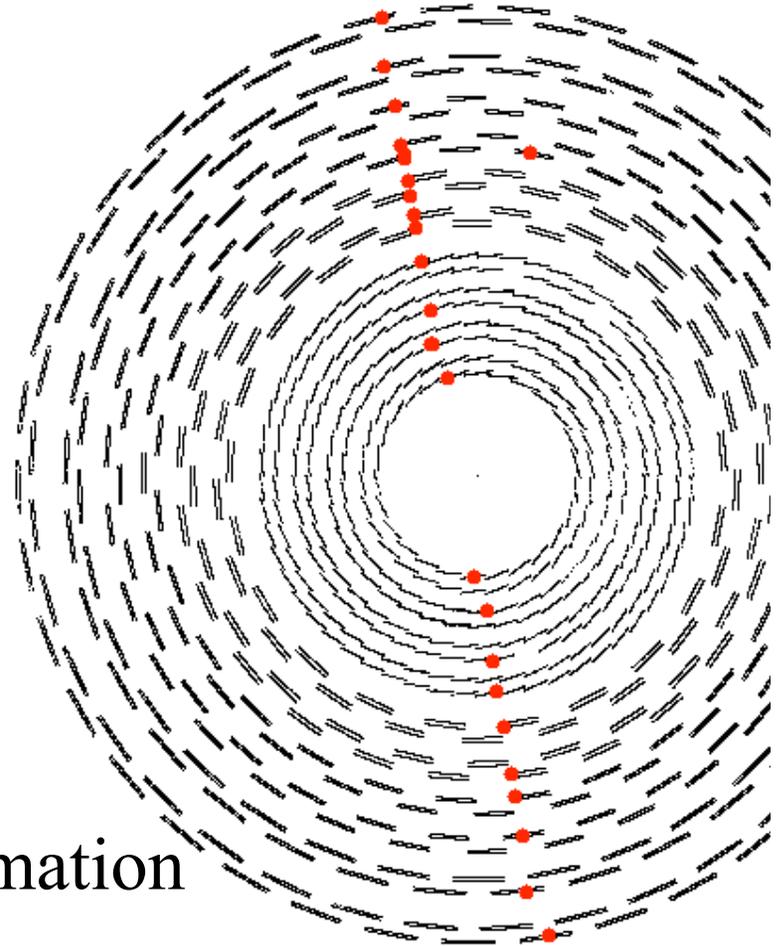
1. Brute force combinatorics
2. Pattern matching
3. Seeding based on other information



Pattern recognition

Three approaches:

1. Brute force combinatorics
 - Too slow
2. Pattern matching
3. Seeding based on other information



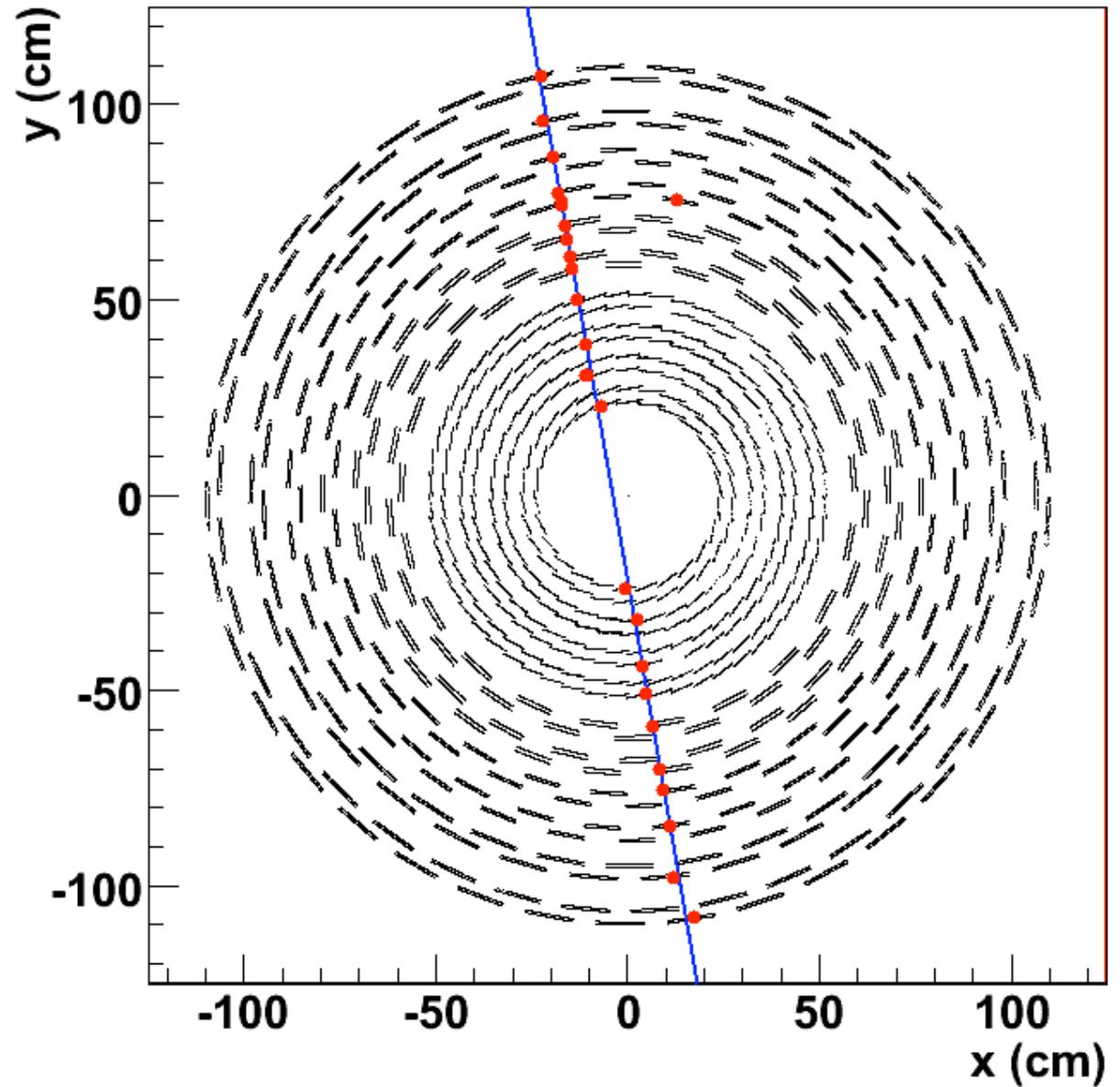
Pattern matching

Find the track(s).

Here is a hint...

Obtained \sim by fitting all hits to a straight line within root.

Cheating?



Pattern matching

Try several hints...

look for hits in a window.

```
if (NhitsInWindow > nMin)
```

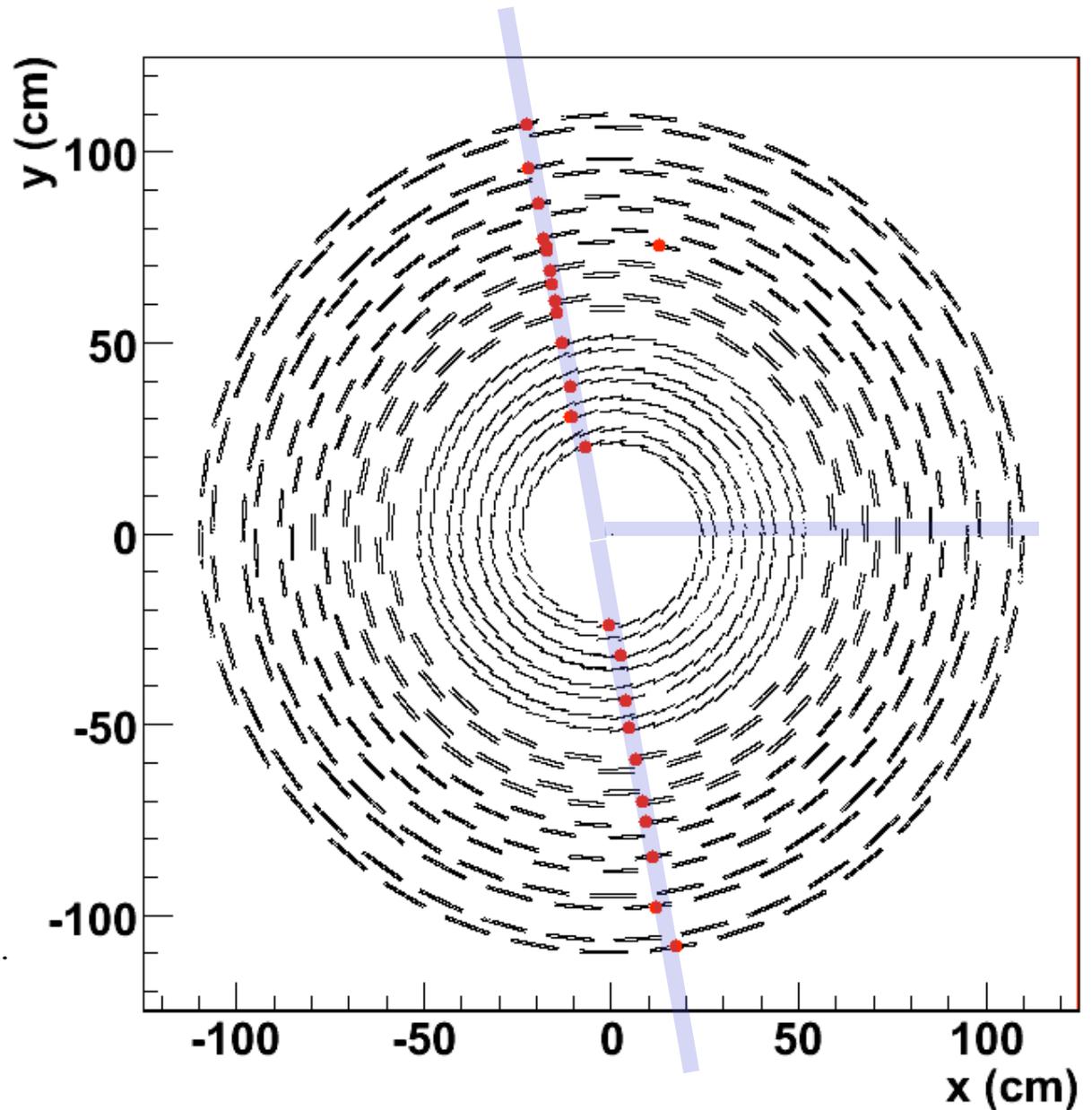
```
    track = true
```

```
else
```

```
    track = false
```

Likewise, look for hits in all windows.

Well suited to a trigger using
parallel AND gates.



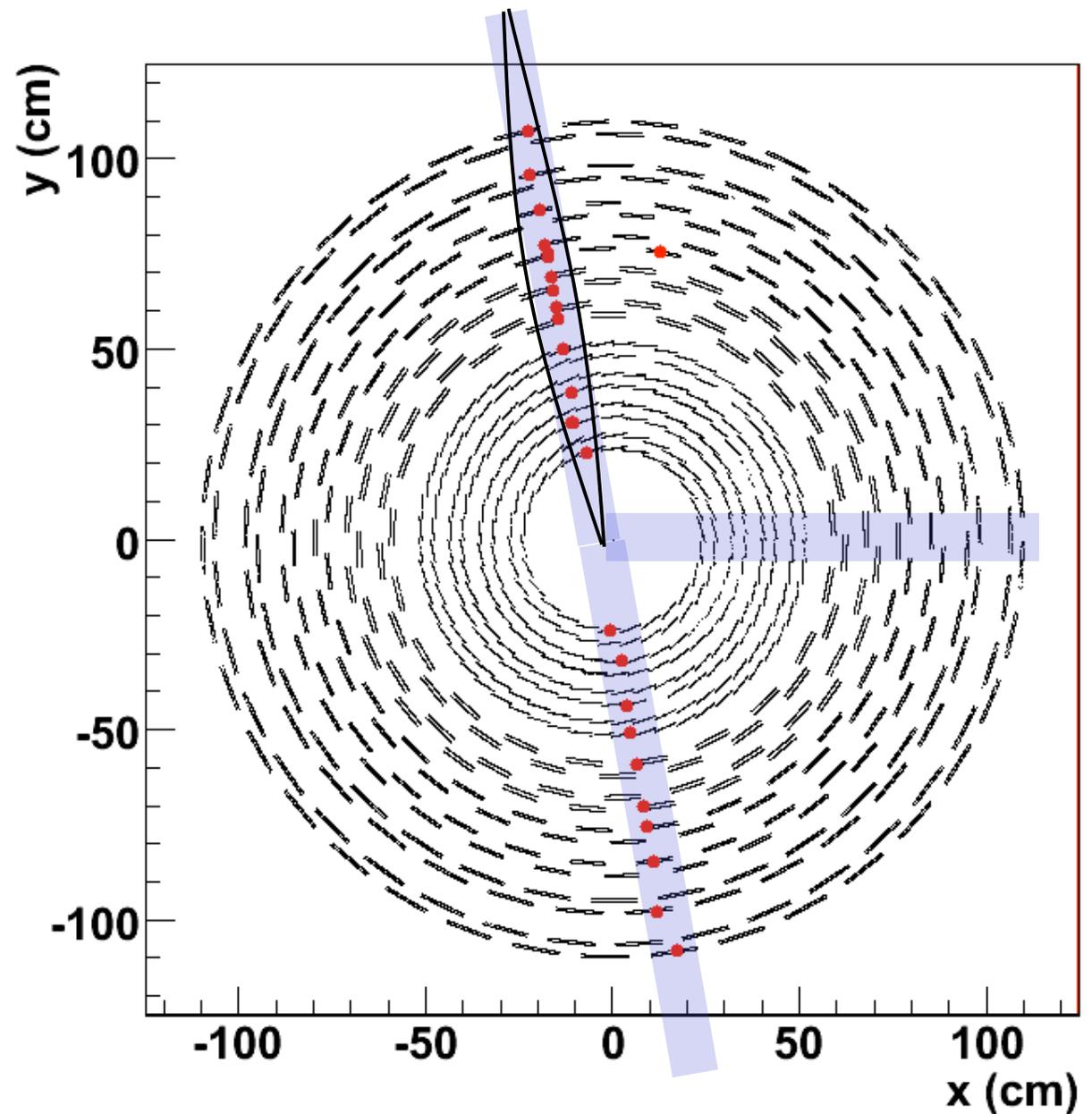
Pattern matching

What about curvature?

Widen window for
lower p_T .

If sufficient hits,
then track with $|p_T| > \min p_T$

Still well-suited to trigger.

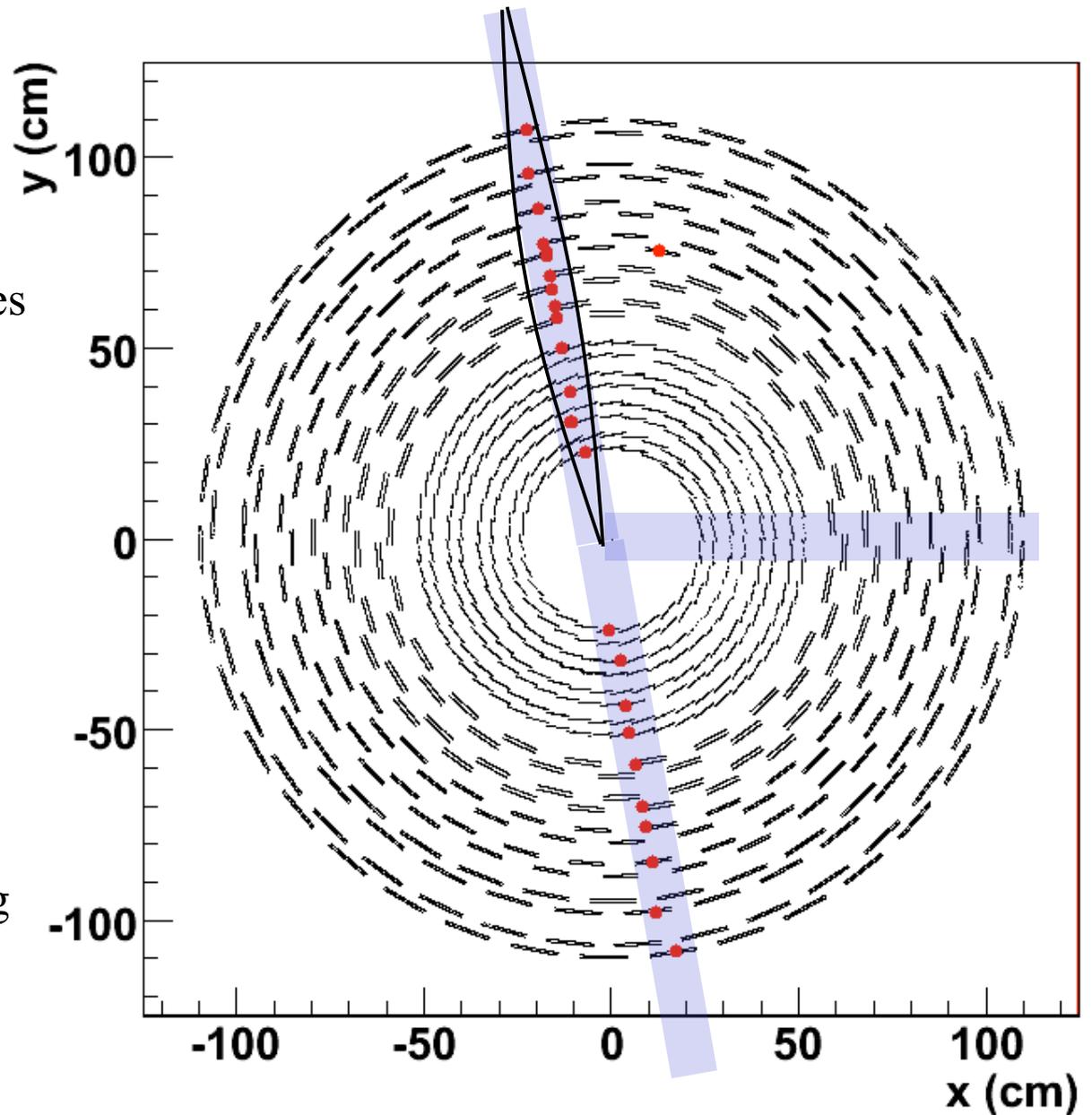


Pattern matching

Limitations:

- Confusable if several particles in the window.
- Assumes that the particle came from the beamspot.

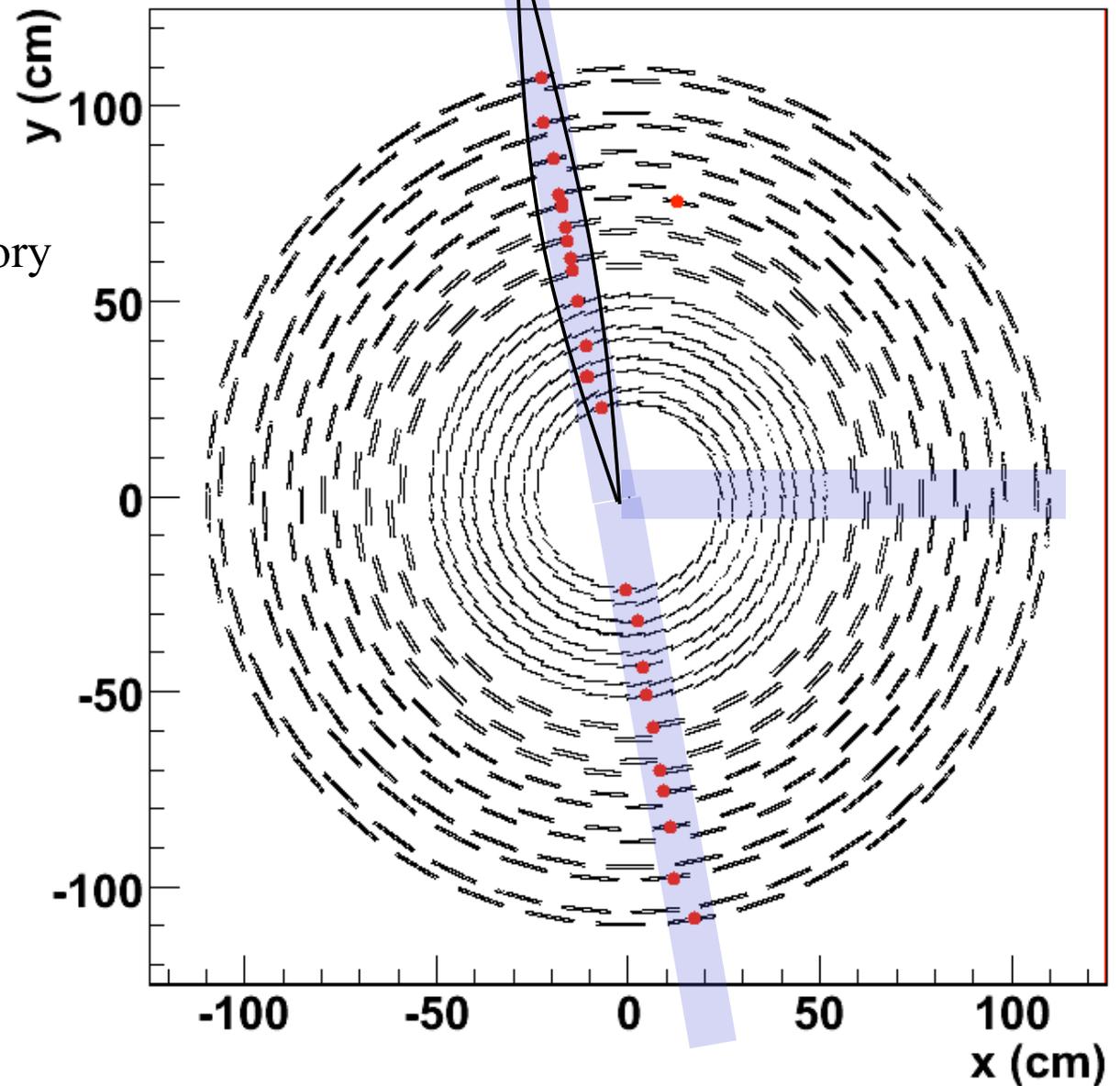
Neither is serious for matching tracks to primary leptons.



Matched pattern matching

For matching tracks to
isolated lepton (e.g. electron)
we already ~ know the trajectory
from the calorimeter.

Only need to search in one
 p_T constrained window.



Pattern recognition

Three approaches:

1. Brute force combinatorics
2. Pattern matching:
 - Fast and parallelizable
 - Finds tracks “above some p_T cut”
 - Can be limited by other information
3. Seeding based on other information
 - Can be **constrained** by other information

Seeded hit search

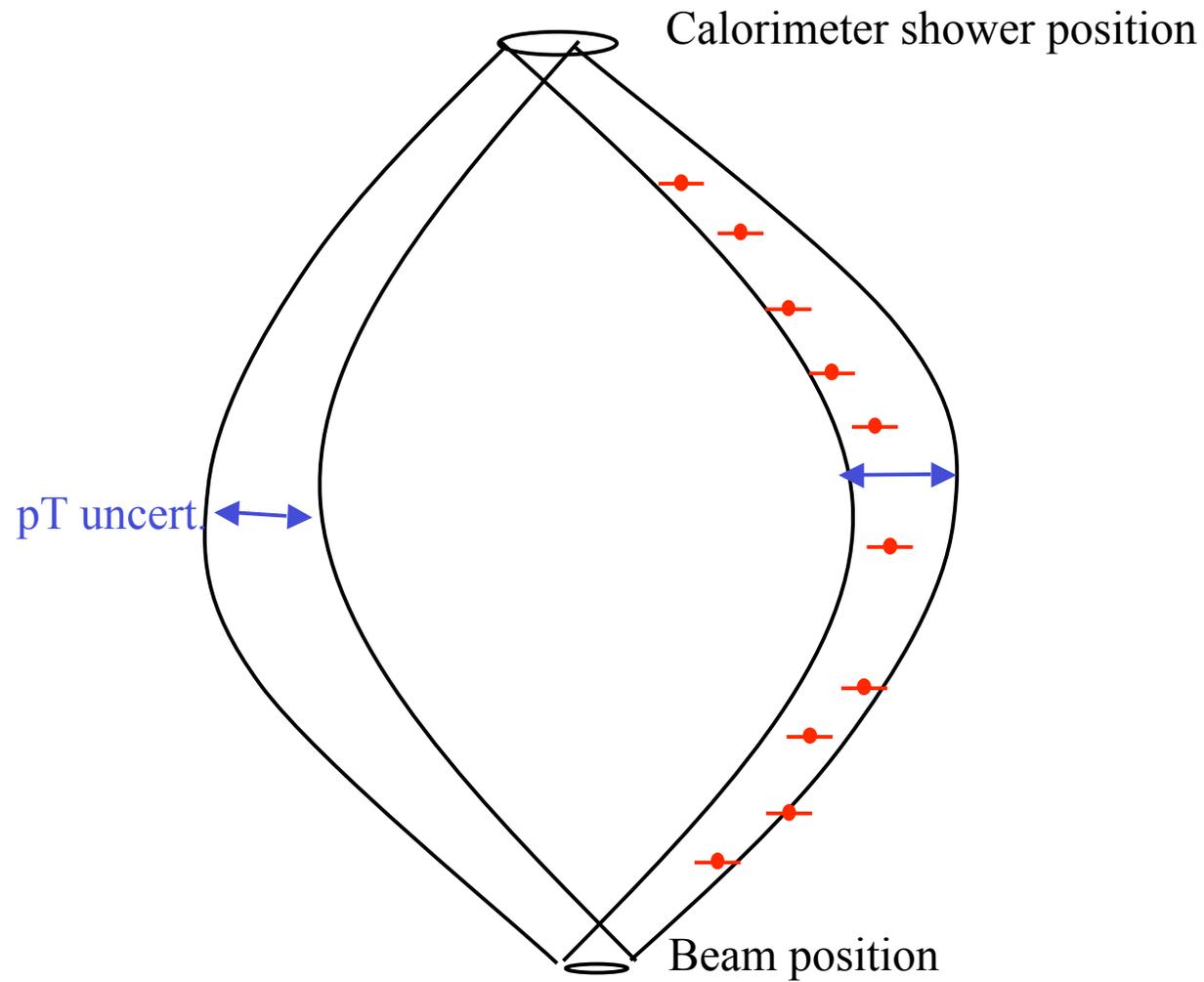
If we had a hypothesis, e.g., electron, use that “seed” fully.

Know position and p_T **and** their uncertainties.

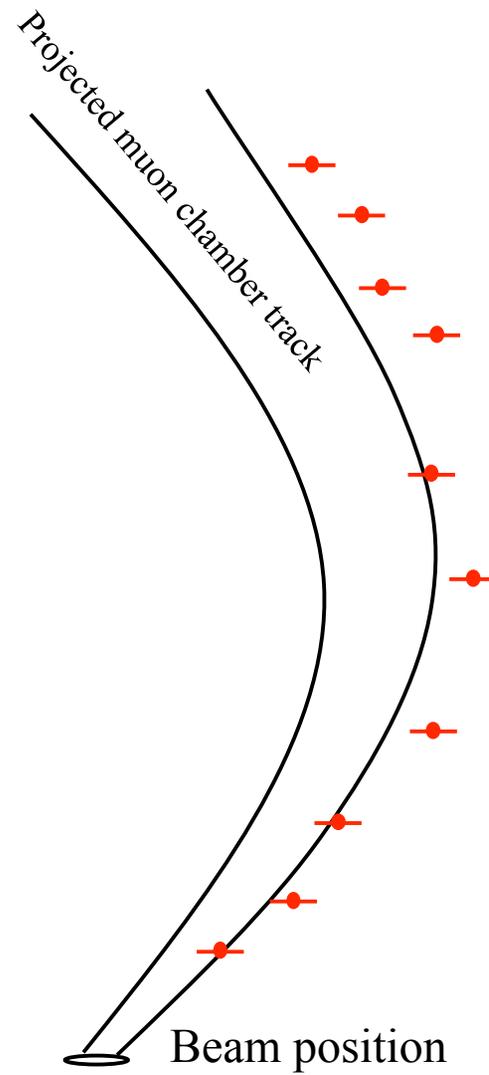
Don't know charge.

So...

Electron seeded hit search



Muon seeded hit search



Pattern recognition

Three approaches:

1. Brute force combinatorics
2. Pattern matching:
 - Fast and parallelizable
 - Finds tracks “above some p_T cut”
 - Can be limited by other information
3. Seeding based on other information
 - Can be **constrained** by other information
 - Useful e.g., for leptons.
4. A mixture: combinatoric pattern seeding?

Pattern recognition

Combinatoric segment finding in one supercell:

Pick end points \Rightarrow line (with uncert.)

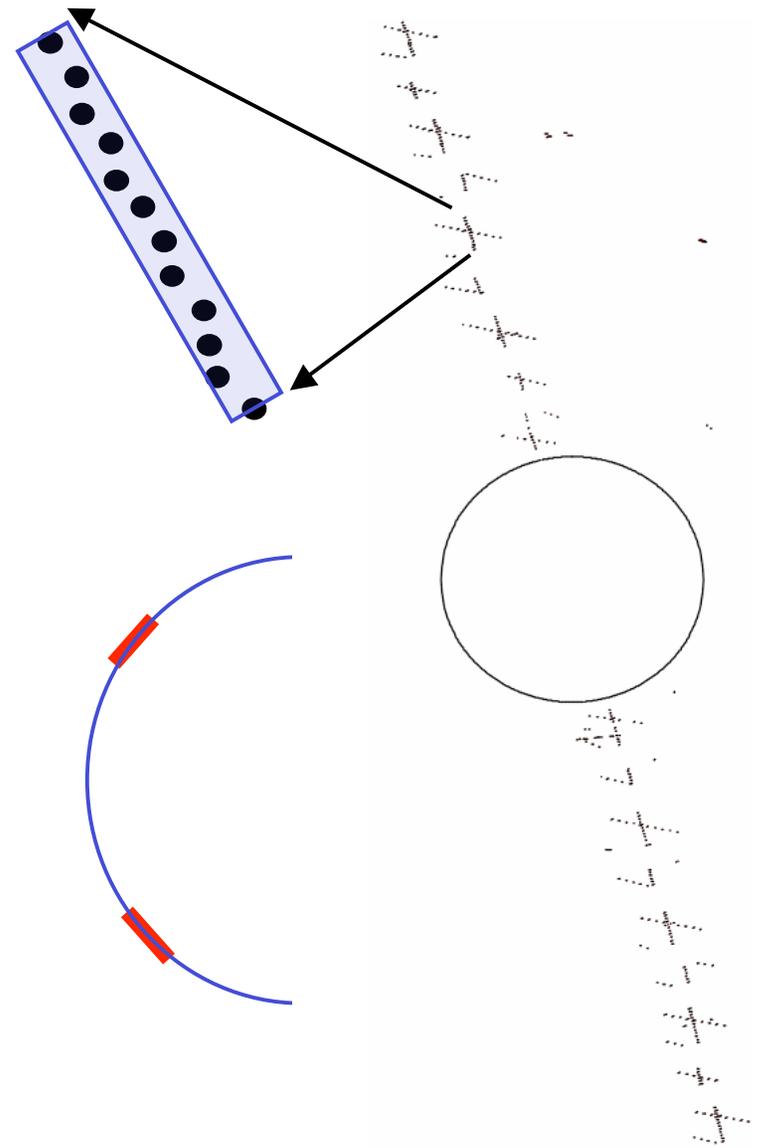
Pattern match in the window. Track?

Fit straight line (at this small lever arm, \sim straight)

Remove outliers and refit.

Use this segment as a hypothesis (seed) to find

- hits in other super-layers
- matching segments in other super-layers



Pattern recognition

Combinatoric segment finding in one supercell:

Pick end points \Rightarrow line (with uncert.)

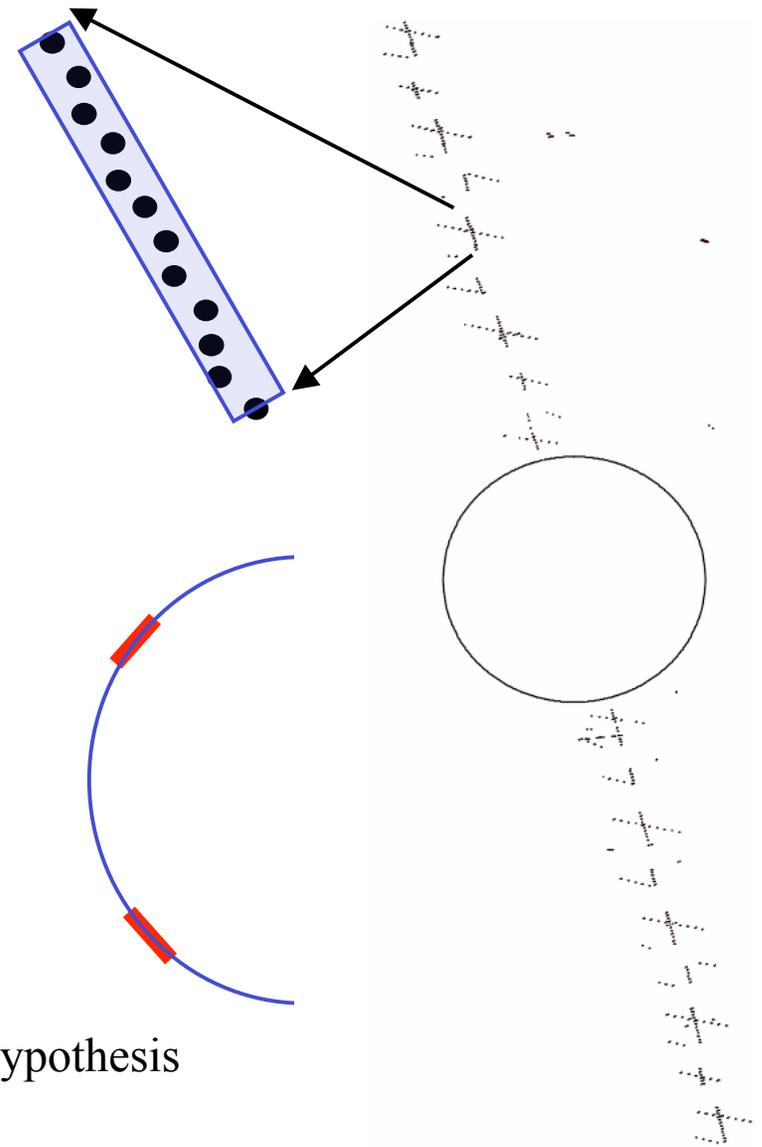
Pattern match in the window. Track?

Fit straight line (at this small lever arm, \sim straight)

Remove outliers and refit.

Use this segment as a hypothesis (seed) to find

- hits in other super-layers
- matching segments in other super-layers



In short: Use the scientific method.

Measurement \rightarrow Hypothesis \rightarrow Measurement \rightarrow Better hypothesis

Fitting

The pattern recognition found a set of hits associated to one particle.

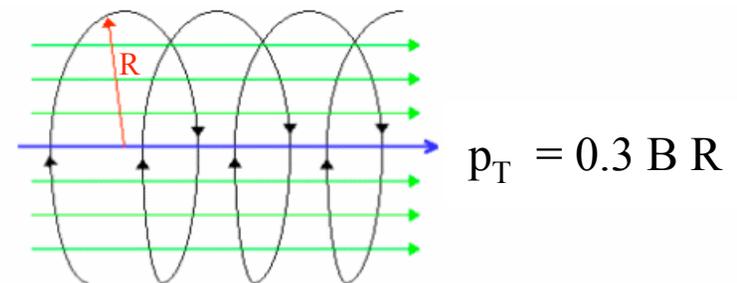
Now fit them to find the path.

For a straight line, that is easy:

```
myGraphXvsY->Fit("pol1");
myGraphRvsZ->Fit("pol1");
```

With a magnetic field, though, need to find:

- Momentum, actually p_T , actually R .
- Direction (phi and theta)
- Point of origin



Describing a helix

$$x(t) = x_0 + \rho \cos(\omega t - \alpha_0)$$

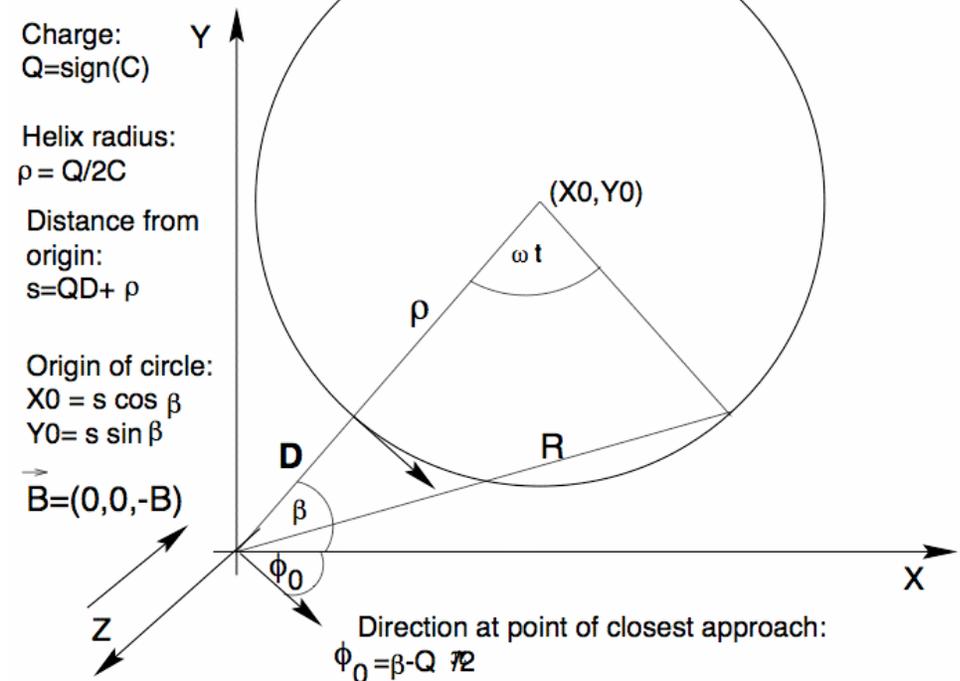
$$y(t) = y_0 + \rho \sin(\omega t - \alpha_0)$$

$$z(t) = z_0 + c\beta_z t = z_0 + \frac{\rho\omega t}{c} \cot \theta$$

where:

$$\omega = \frac{c\beta_{\perp}}{\rho} : \text{angular velocity}$$

$$\frac{\beta_z}{\beta_{\perp}} = \frac{P_z}{P_t} = \cot \theta$$



This works, but direction and origin are vague

Hanz Wenzel, CDF Note 1790

Describing a helix

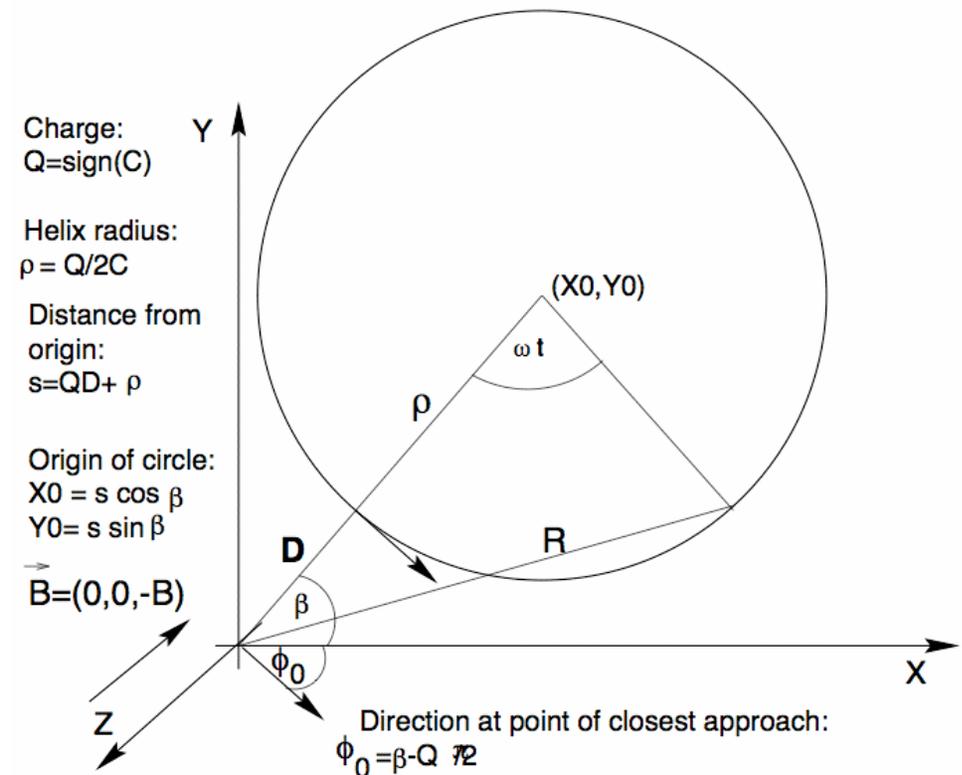
$$\left. \begin{aligned}
 x(t) &= x_0 + \rho \cos(\omega t - \alpha_0) \\
 y(t) &= y_0 + \rho \sin(\omega t - \alpha_0) \\
 z(t) &= z_0 + c\beta_z t = z_0 + \frac{\rho\omega t}{c} \cot \theta
 \end{aligned} \right\} \begin{aligned}
 x &= x_0 + Q\rho \sin(Q\lambda + \varphi_0) \\
 y &= y_0 - Q\rho \cos(Q\lambda + \varphi_0) \\
 z &= z_0 + \rho\lambda \cot \theta
 \end{aligned}$$

Where

$$\lambda = \omega t$$

and

$$\rho = \frac{1}{2QC}$$



Hanz Wenzel, CDF Note 1790

Describing a helix

Five helix parameters: Simple functions for phi or z at any R:

C: [half] curvature, signed

$\cot(\theta)$: polar angle

$$\varphi(R, \vec{\alpha}) = \varphi_0 + \sin^{-1} \left(\frac{CR + (1 + CD)D/R}{1 + 2CD} \right)$$

D: Distance of closest approach to origin.

(Also called

impact parameter, d_0).

$$Z(R, \vec{\alpha}) = z_0 + \frac{\cot \theta}{C} \sin^{-1} \left(C \sqrt{\frac{R^2 - D^2}{1 + 2CD}} \right)$$

ϕ_0 : Phi at closest approach

...so, you can make your own simple event display in root.

(Beware that your software may not use half curv.)

z_0 : z at closest approach

Fitting

So, fit the helix to the collected hits and obtain the five helix parameters and their uncertainties.

Then find momentum from:

$$C = Q \cdot \frac{1.49898 \cdot 10^{-4} \cdot B_{magnet}}{P_t}$$

and

$$\cot\theta = \frac{P_z}{P_t}$$

and propagate the uncertainties.

Fitting

That is pretty good, but it neglects two effects:

- dE/dx
- Multiple Coloumb Scattering

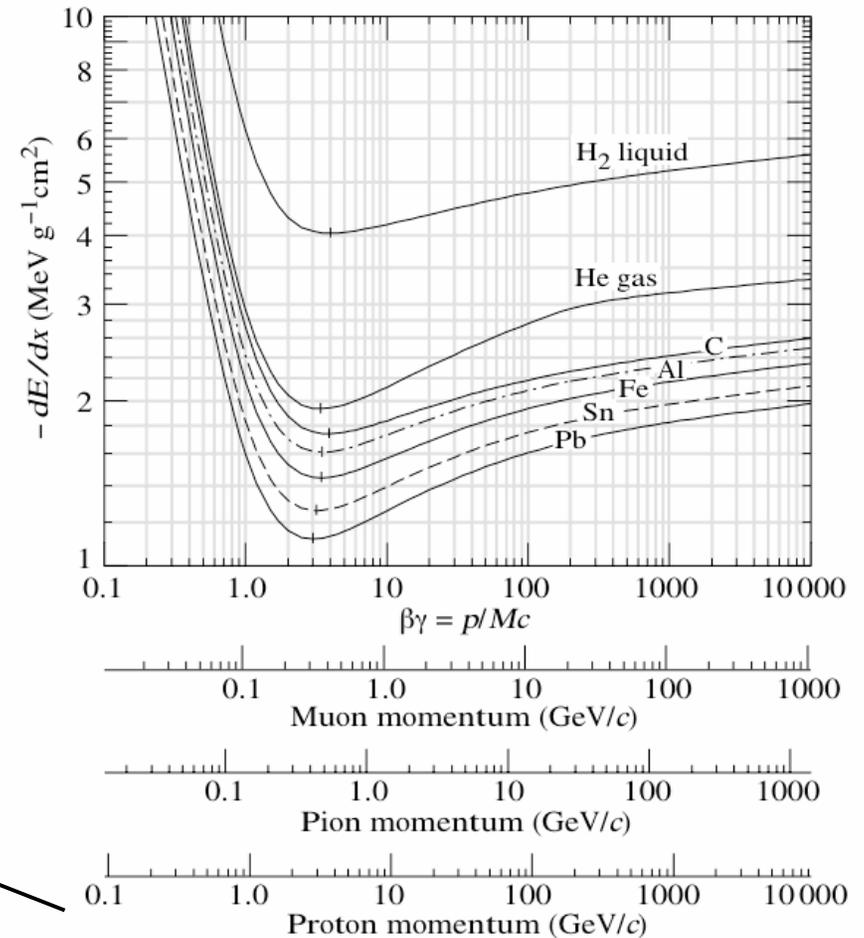
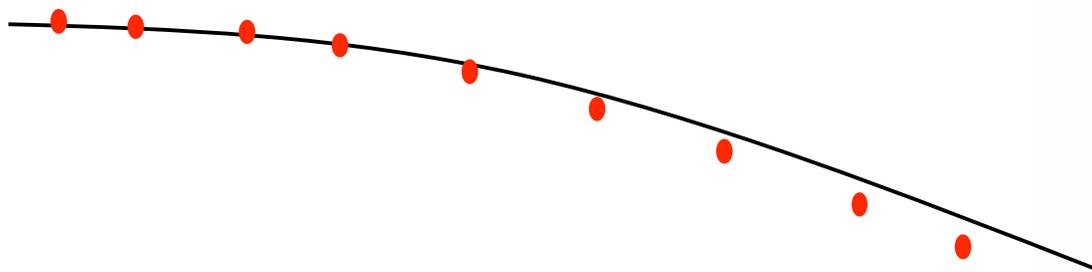
Ionization energy loss, dE/dx

$$-\frac{dE}{dx} = K z^2 \frac{Z}{A} \frac{1}{\beta^2} \left[\frac{1}{2} \ln \frac{2m_e c^2 \beta^2 \gamma^2 T_{\max}}{I^2} - \beta^2 - \frac{\delta(\beta\gamma)}{2} \right]$$

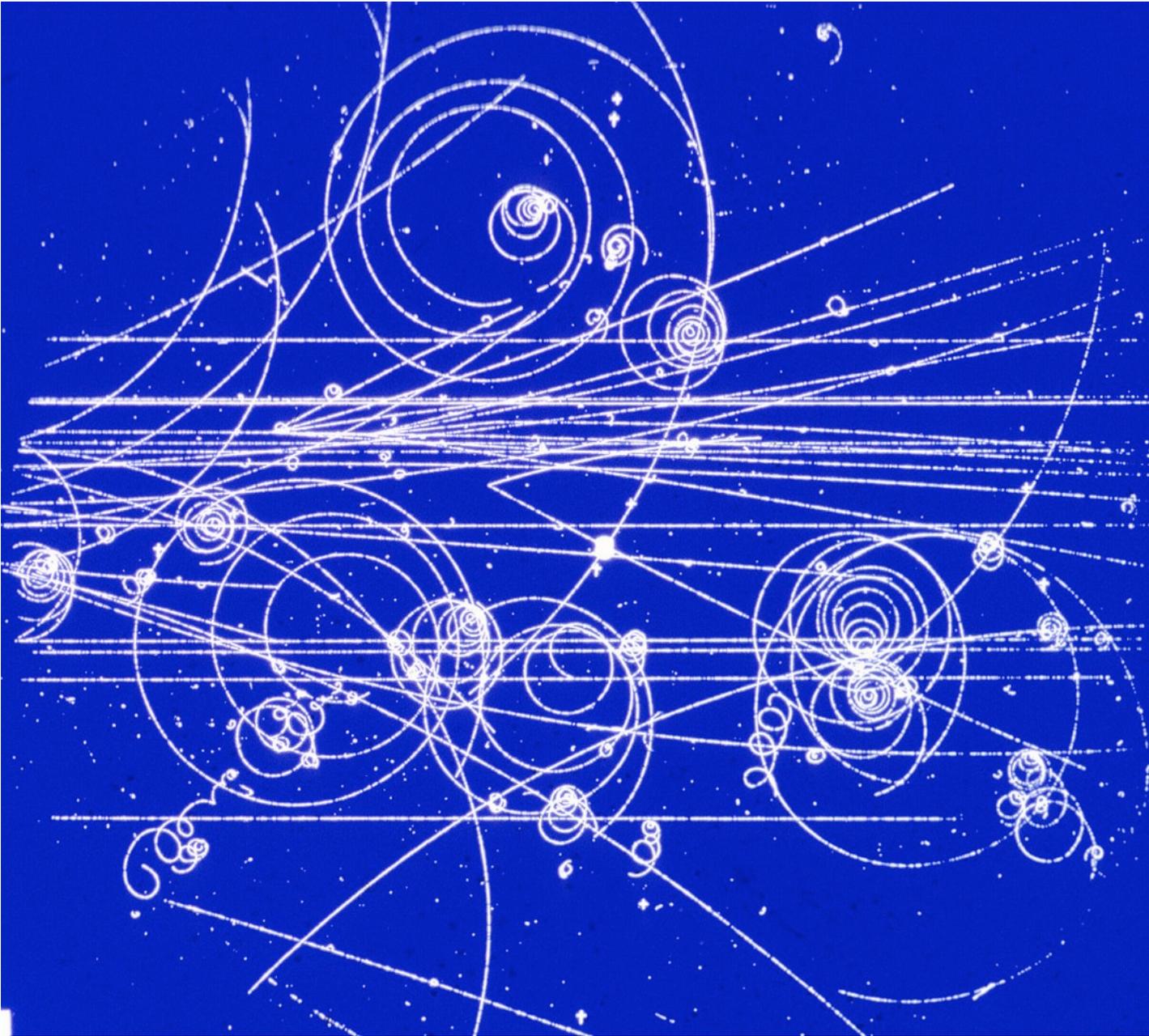
Air: ~ 2 keV/cm

Silicon: ~ 120 keV/ $300 \mu\text{m}$

Fit should include this
(but now we need to know M)...



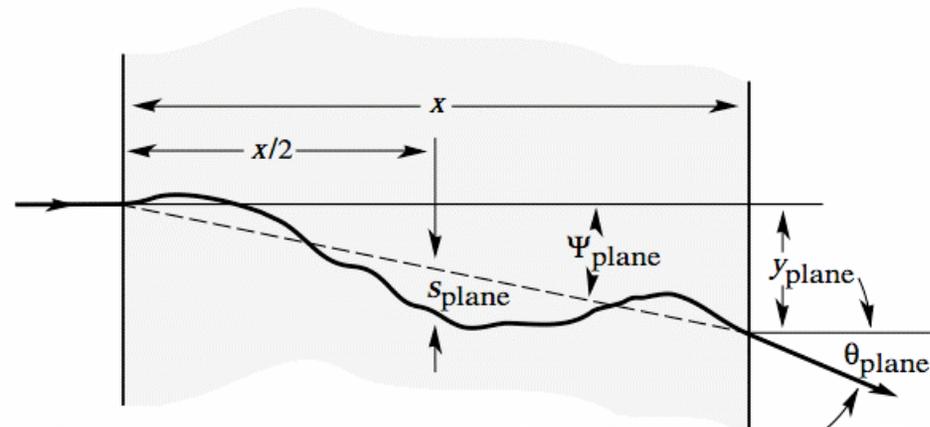
An example of dE/dx affecting tracks. An old CERN bubble chamber event.



An example of dE/dx affecting tracks. An old CERN bubble chamber event.



Multiple Coulomb Scattering



Often just called
Coulomb scattering
or simply scattering.

Figure 27.9: Quantities used to describe multiple Coulomb scattering. The particle is incident in the plane of the figure.

$$\theta_{\text{rms}} = \frac{13.6 \text{ MeV}}{\beta c p} q \sqrt{x/X_0} \left[1 + 0.038 \ln(x/X_0) \right]$$

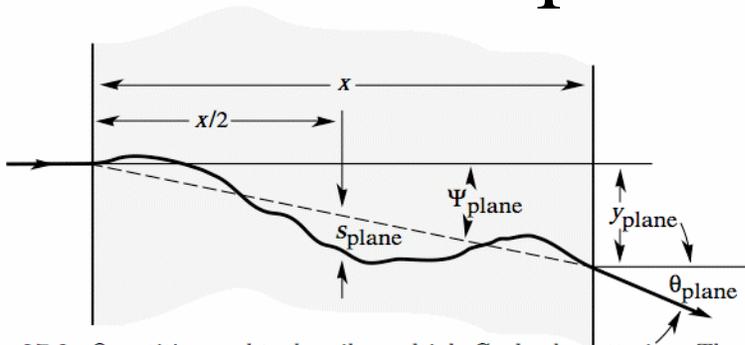
x = thickness

X_0 = radiation length of material

$\approx 100 \text{ m}$ for air $\Rightarrow x/X_0 \approx 0.01\%$ for 1cm of air

$\approx 10 \text{ cm}$ for silicon $\Rightarrow x/X_0 \approx 0.3\%$ for 300 μm of silicon

Multiple Coulomb Scattering

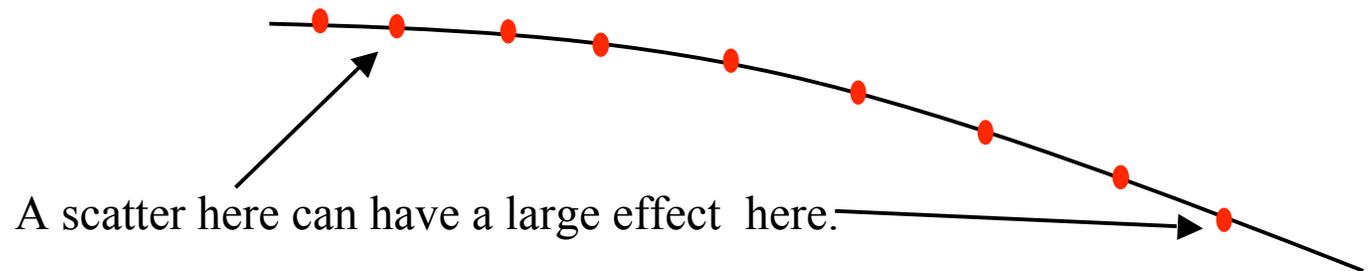


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Figure 27.9: Quantities used to describe multiple Coulomb scattering. The particle is incident in the plane of the figure.

$x/X_0 \approx 0.01\%$ for 1cm of air
 $\Rightarrow 10 \mu\text{m}$ error / meter of projection at 1 GeV.

$x/X_0 \approx 0.3\%$ for 300 μm of silicon
 $\Rightarrow 600 \mu\text{m}$ error / meter of projection at 1 GeV.

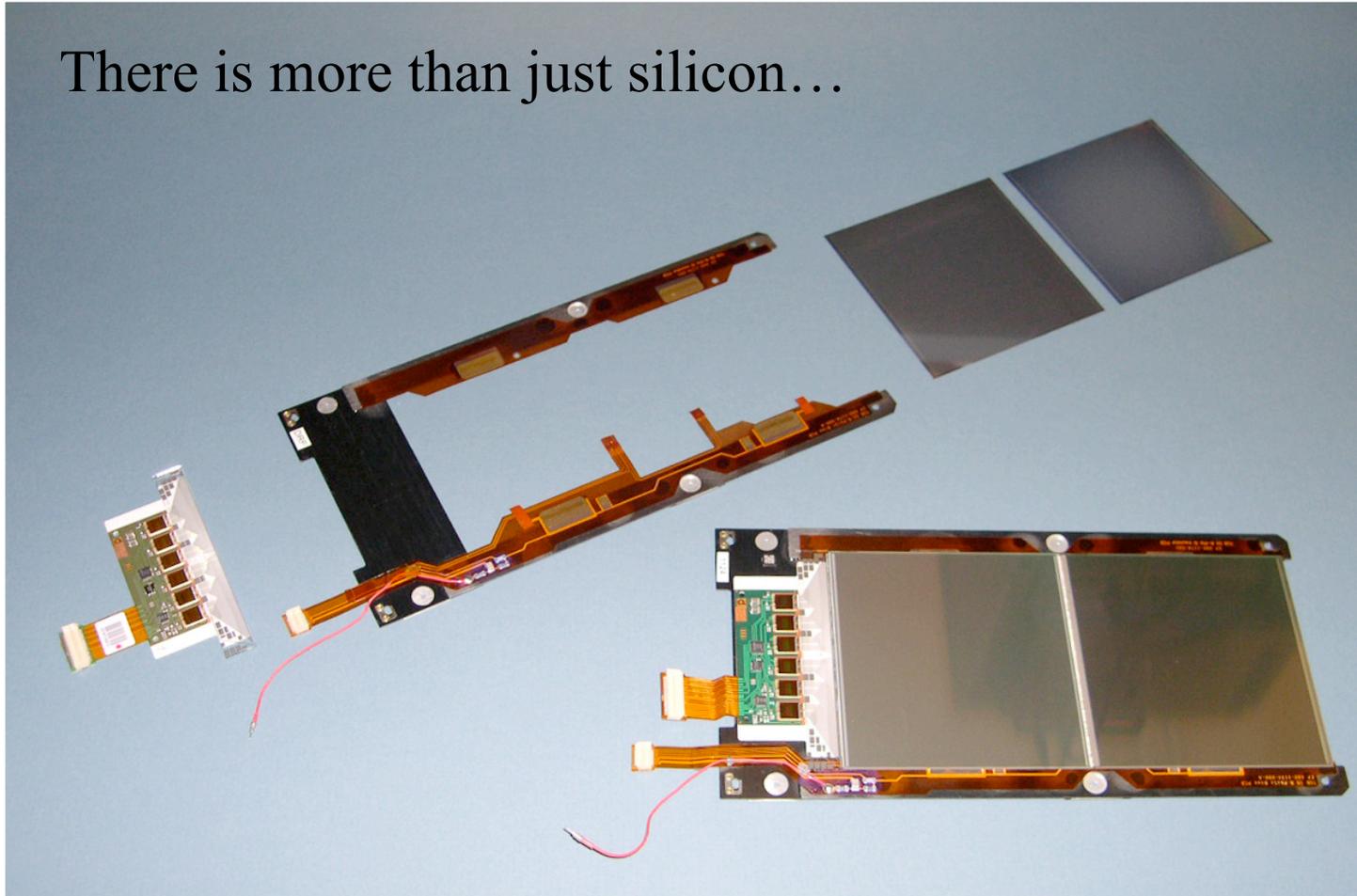


Multiple Coulomb Scattering

$x/X_0 \approx 0.3\%$ for 300 μm of silicon

\Rightarrow 600 μm error / meter of projection at 1 GeV.

There is more than just silicon...

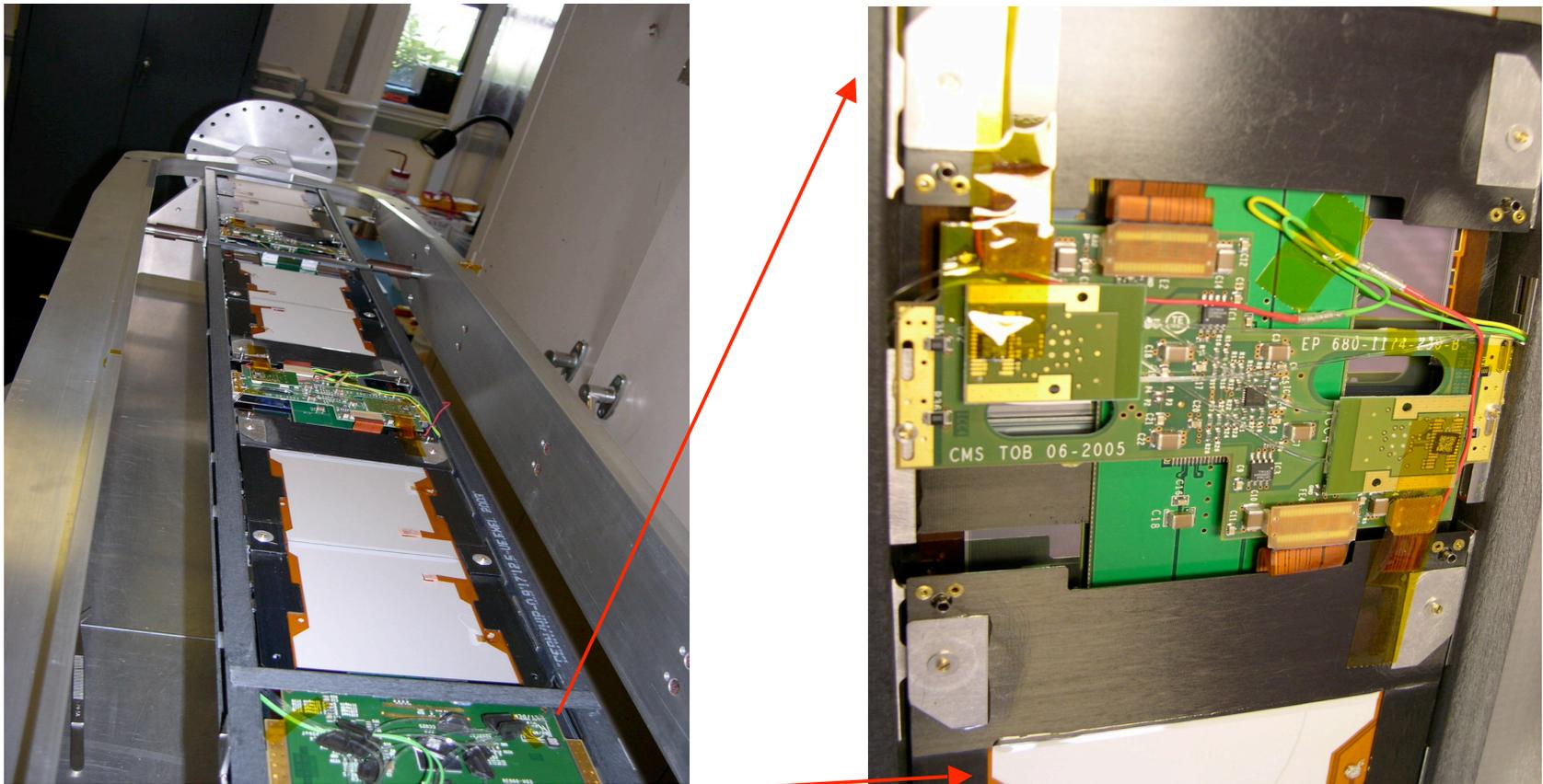


Multiple Coulomb Scattering

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There is more than just silicon...



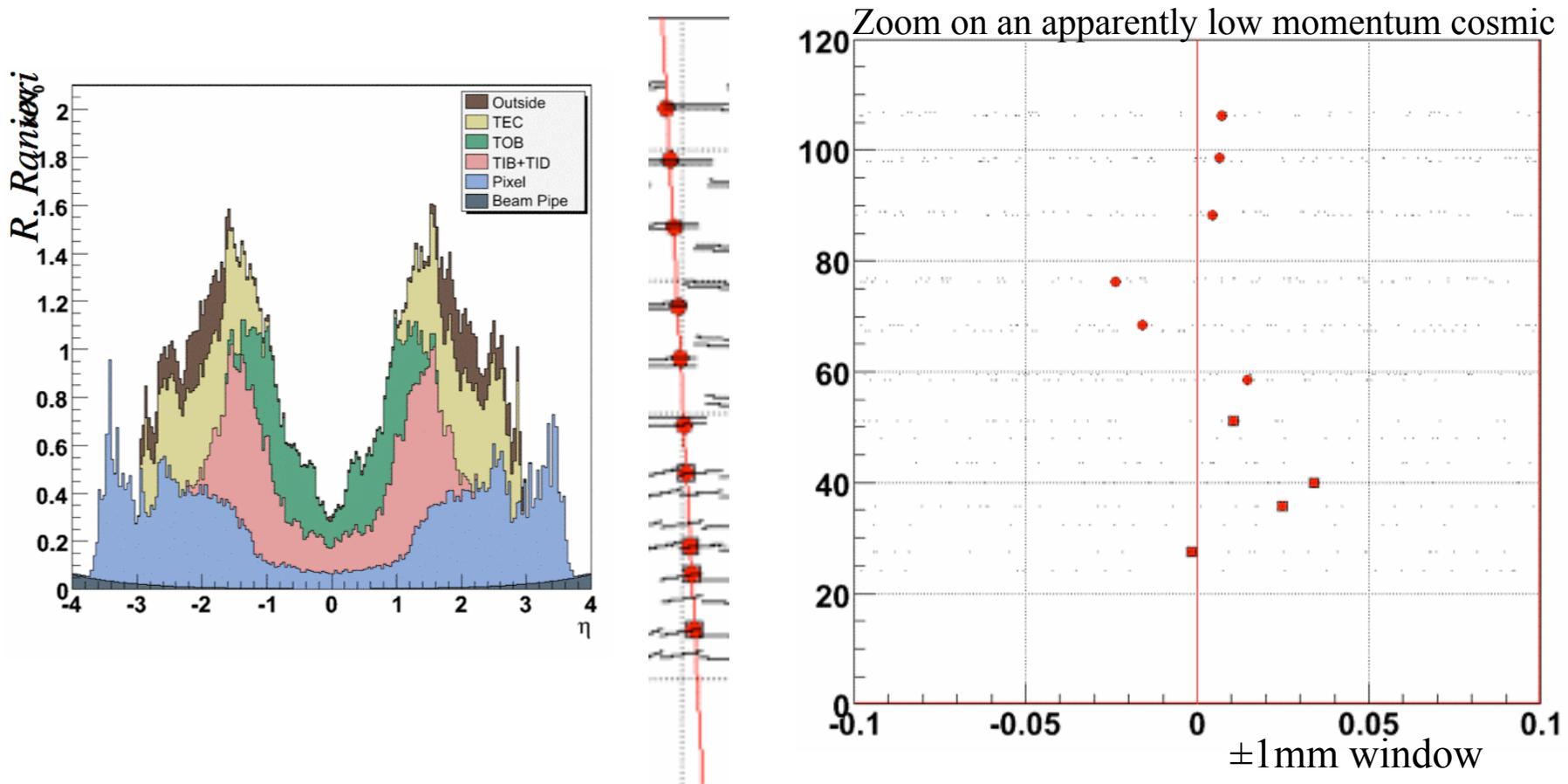
Multiple Coulomb Scattering

$x/X_0 \approx 0.3\%$ for 300 μm of silicon

$\Rightarrow 600 \mu\text{m}$ error / meter of projection at 1 GeV.

$x/X_0 \approx 2.5\%$ for each measurement layer

$\Rightarrow 2 \text{ mm}$ error / meter of projection at 1 GeV.

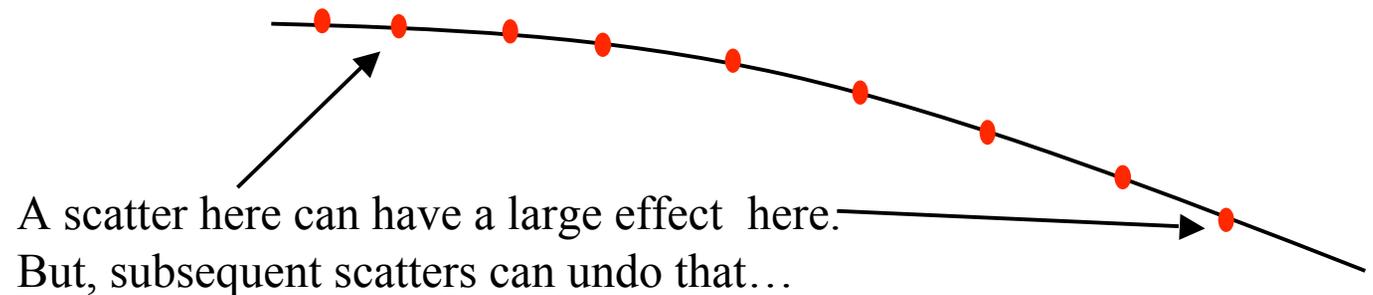


Scattering in each layer can have a large effect downstream, but could be “un-scattered” later....

Fit as you go

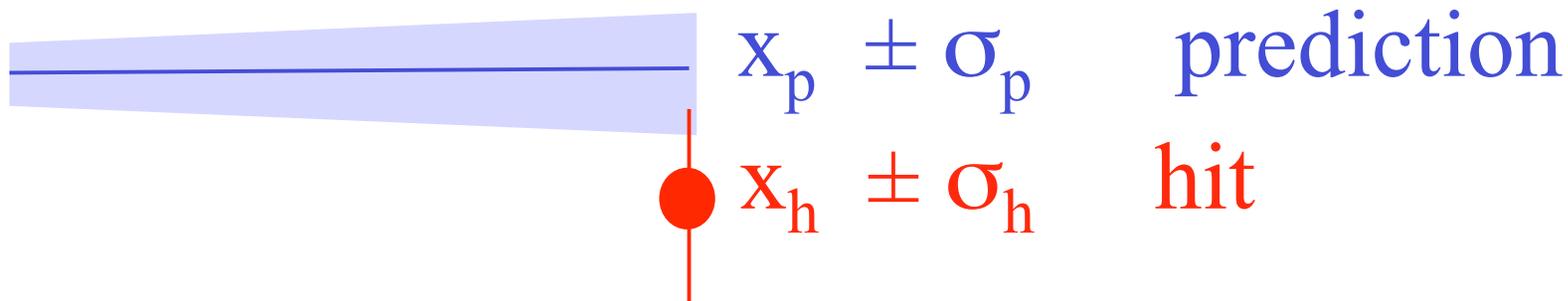
To include energy loss and MCS, we need to fit as we go, hit by hit.
After each hit is added, subtract dE/dx from p and add MCS to uncertainty.

But, each new hit partially measures the effect of any previous scattering...



Fit as you go

- Imagine that we begin with a track hypothesis, e.g., from a seed.
- It has parameters and uncertainties = 5 numbers and a 5x5 covariance matrix
- But I will simplify as one-dimensional, just x and σ_x .
- Project **track (and its uncertainty)** to the first **hit**.
- Test and improve the hypothesis with a new measurement.



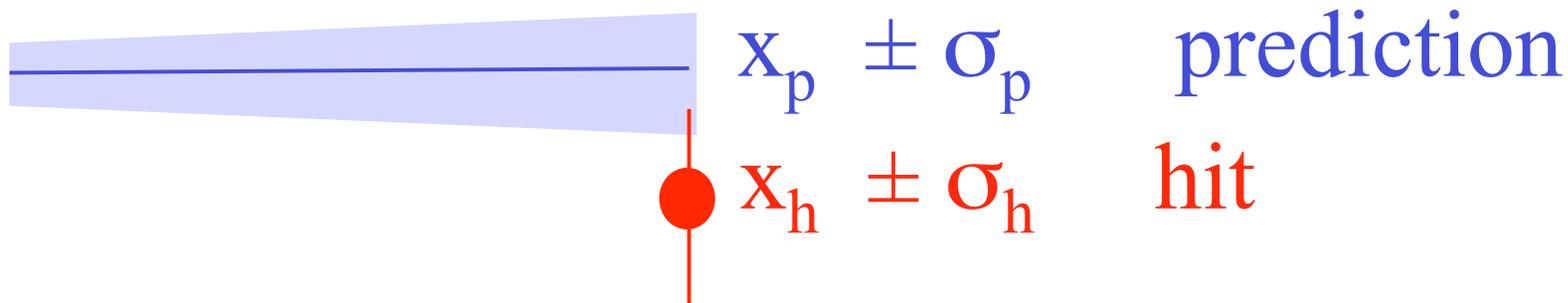
$$\text{New } x = \frac{(x_p / \sigma_p^2) + (x_h / \sigma_h^2)}{(1 / \sigma_p^2) + (1 / \sigma_h^2)} = \text{weighted average}$$

In 5D, it is just the matrix equivalent.

This is called a Kalman Filter, where the filter is just averaging the prediction & measurement.

Kalman Filter

- Ignores a poor prediction
- Ignores a poor measurement
- Naturally iterative
- Short projection may allow approximations



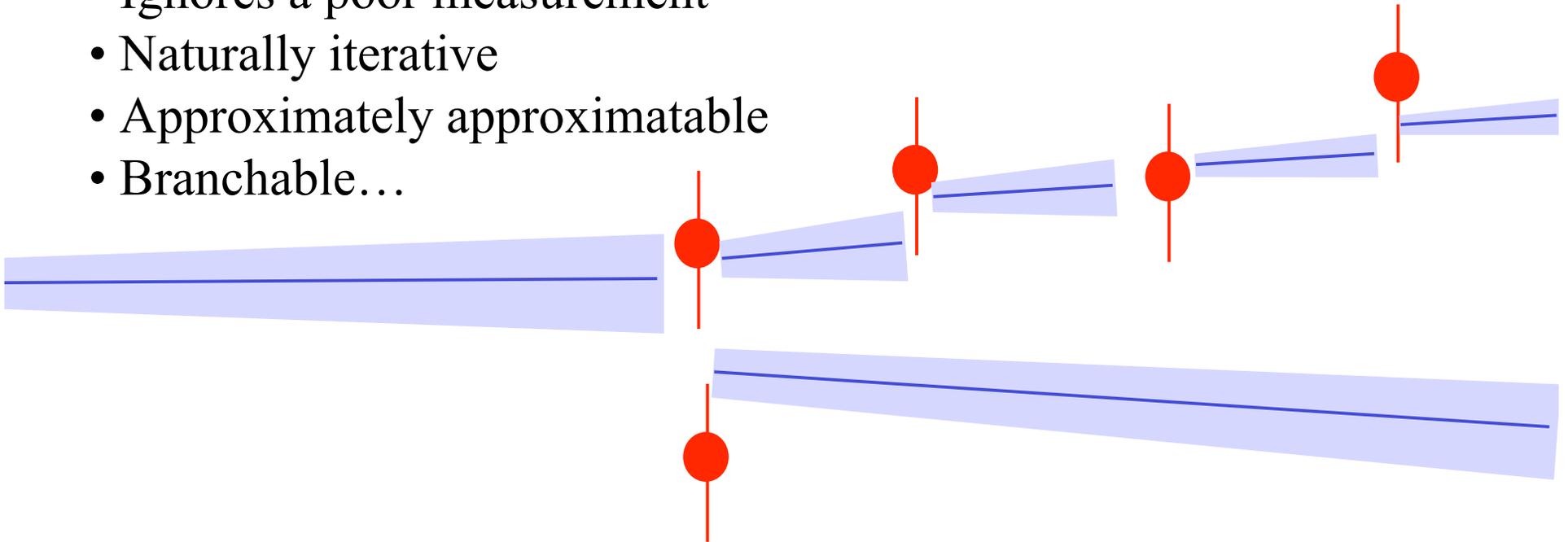
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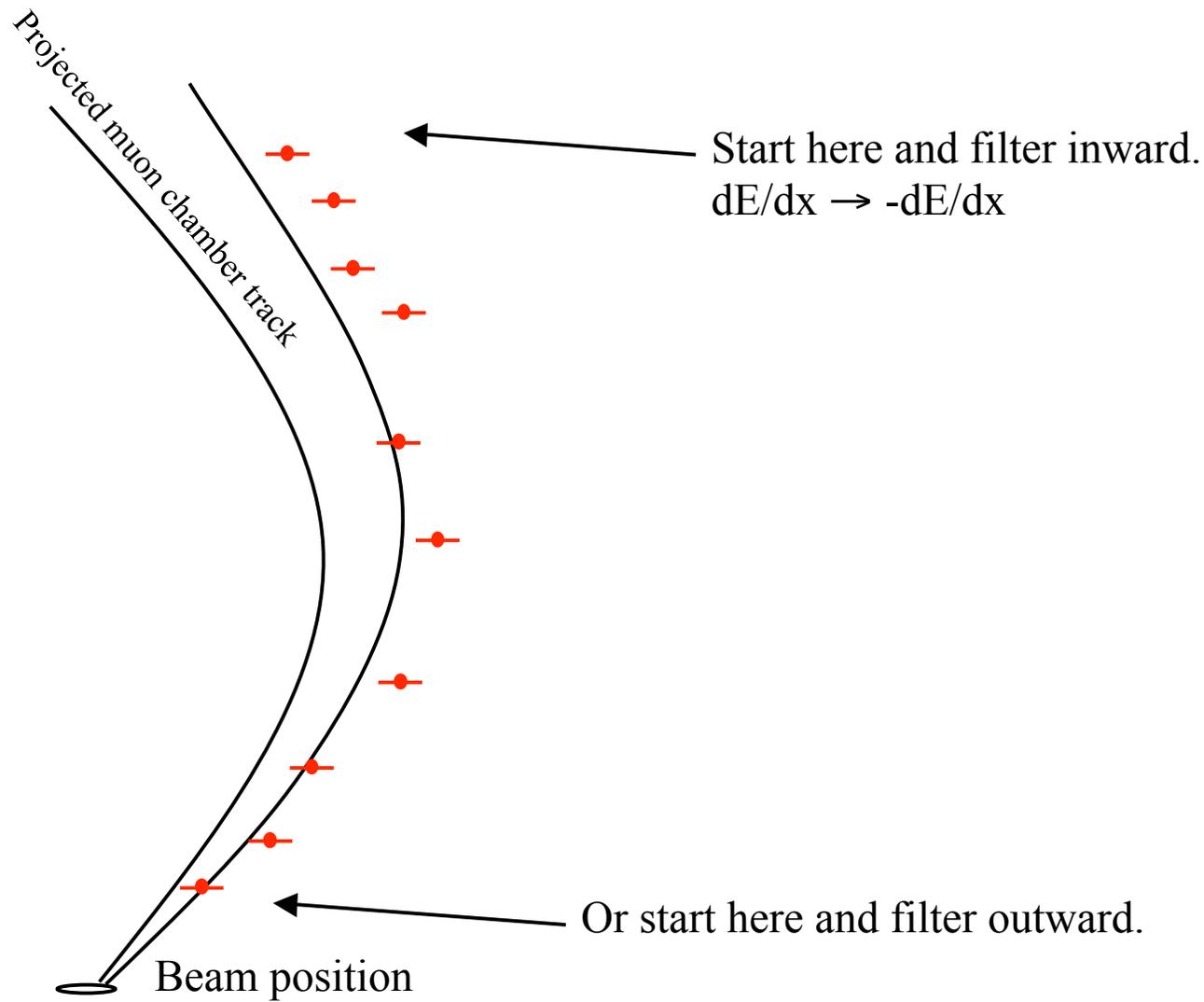
Kalman Filter

- Ignores a poor prediction
- Ignores a poor measurement
- Naturally iterative
- Approximately approximatable
- Branchable...



- Choose at the end which branch is best.
- Can in fact merge this into pattern recognition.

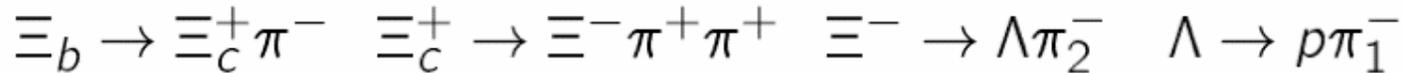
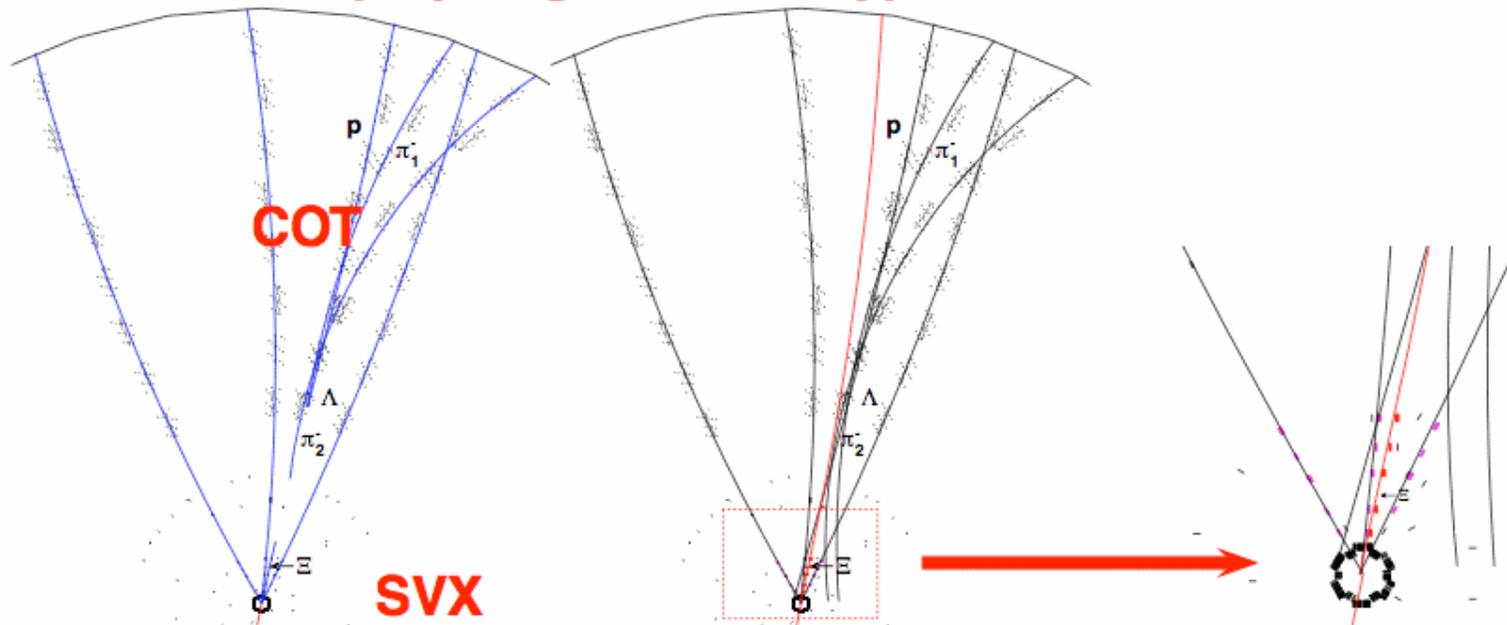
Muon seeded Kalman Filter





Cascade Tracked!

Event Display of generated Hyperons Tracked in Silicon



- Reduce random background - clean Ξ samples
- Improvement in Ξ impact parameter resolution

Possible Algorithms

Seed from other measurement, e.g., electron or muon

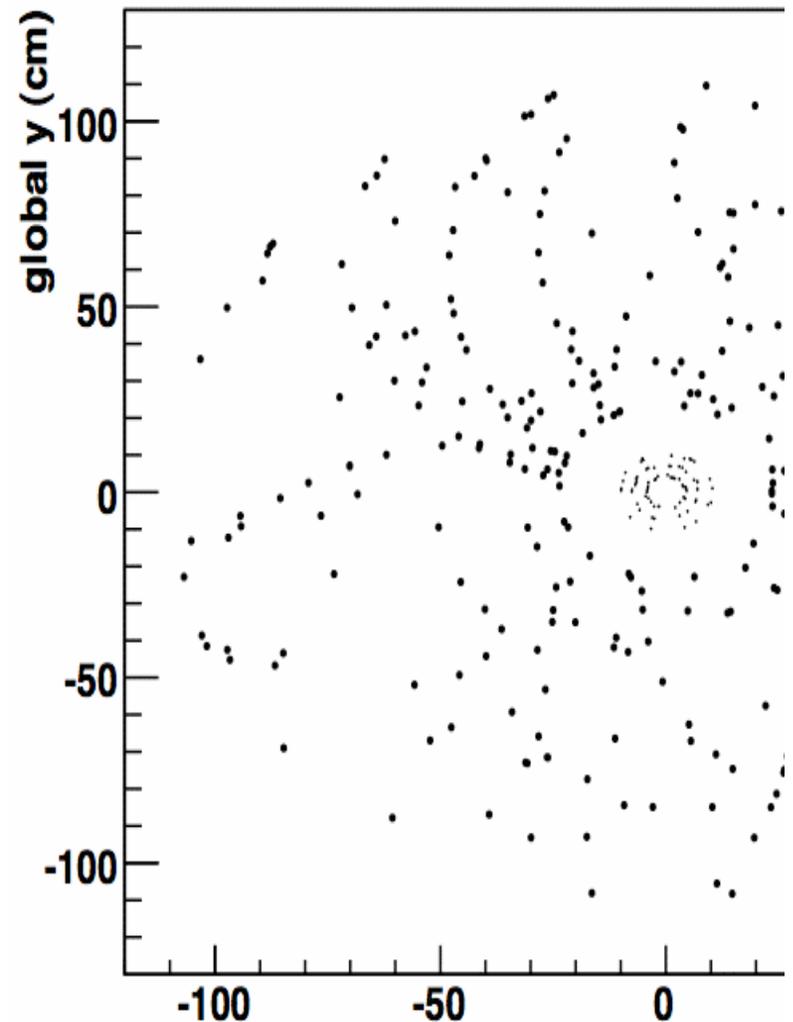
Seed from subset of hits.

Outer hits?

Inner hits?

Combinatorics of all hits

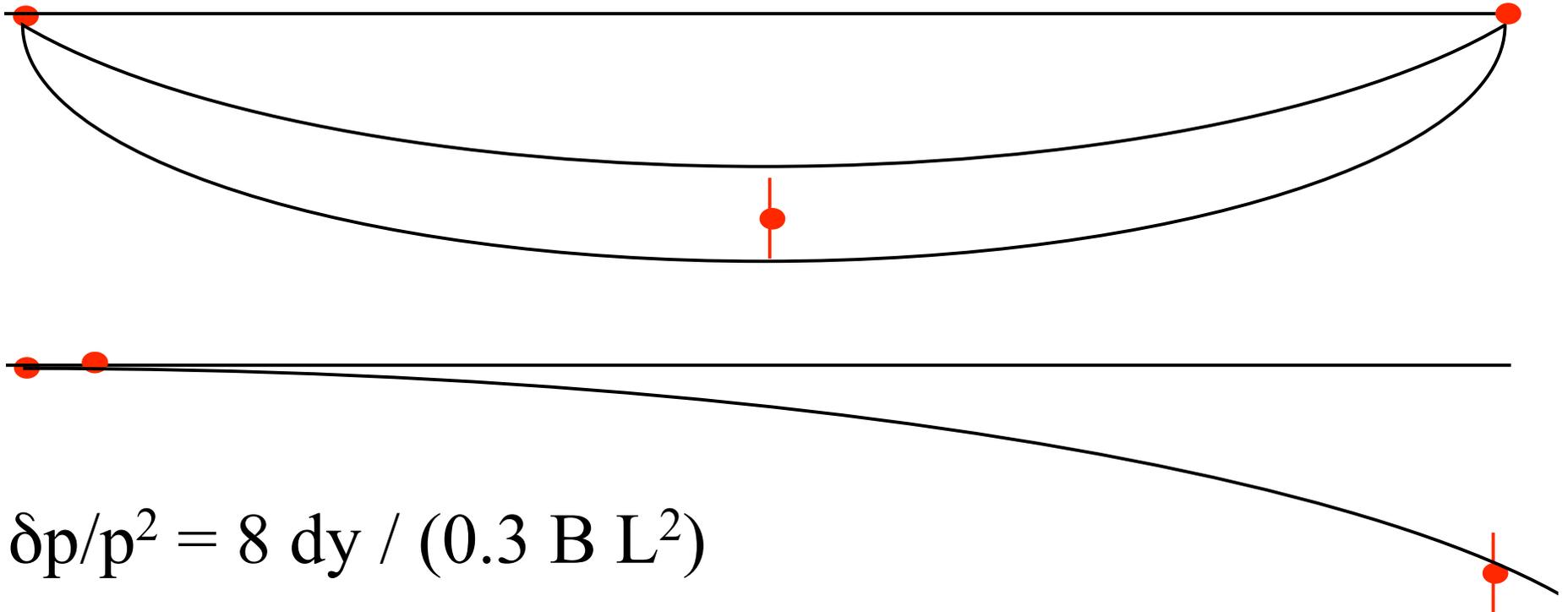
Remove used hits



Track parameter resolution

Momentum resolution \Leftrightarrow curvature resolution

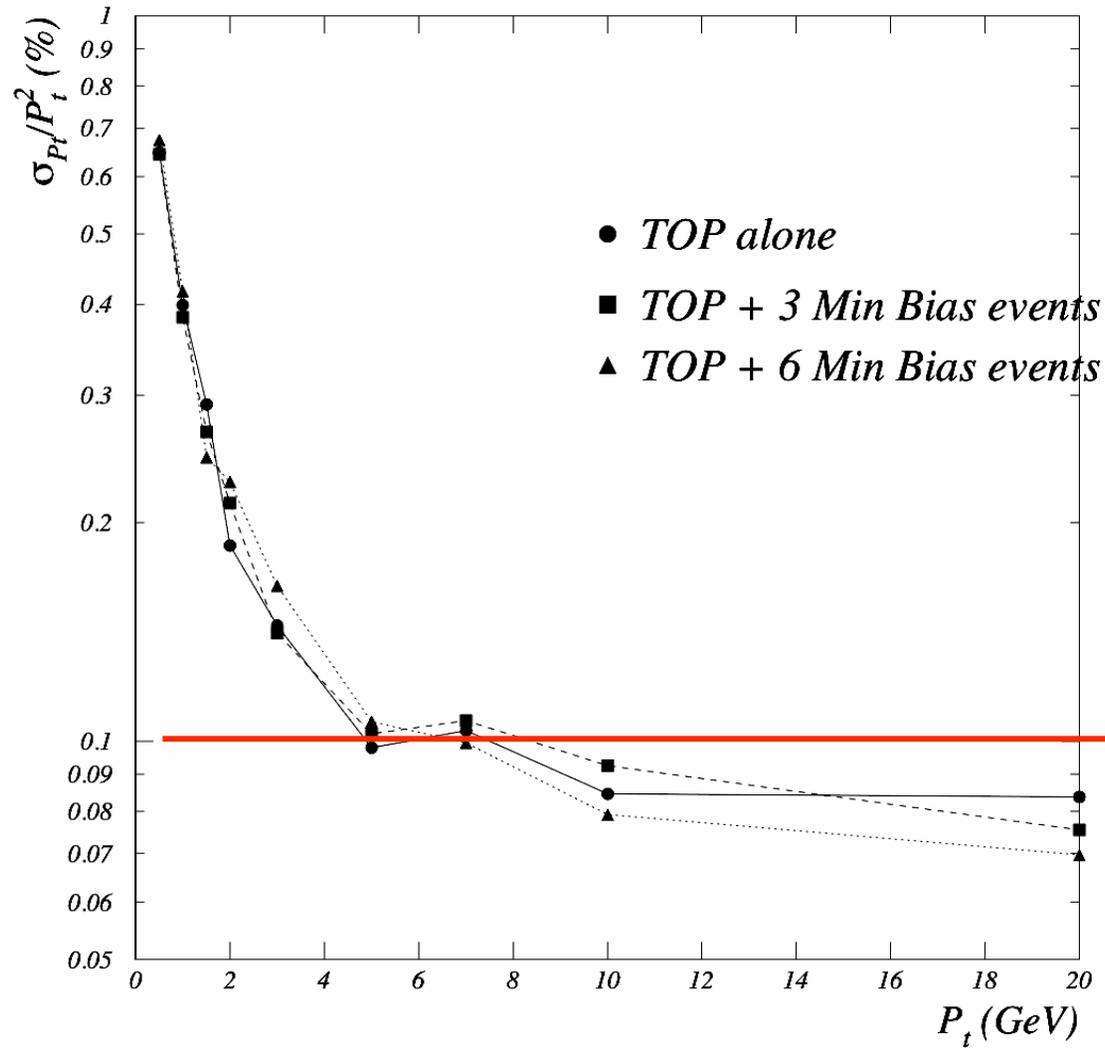
Measuring the sagitta is driven by lever arm.



$$\delta p/p^2 = 8 \, dy / (0.3 \, B \, L^2)$$

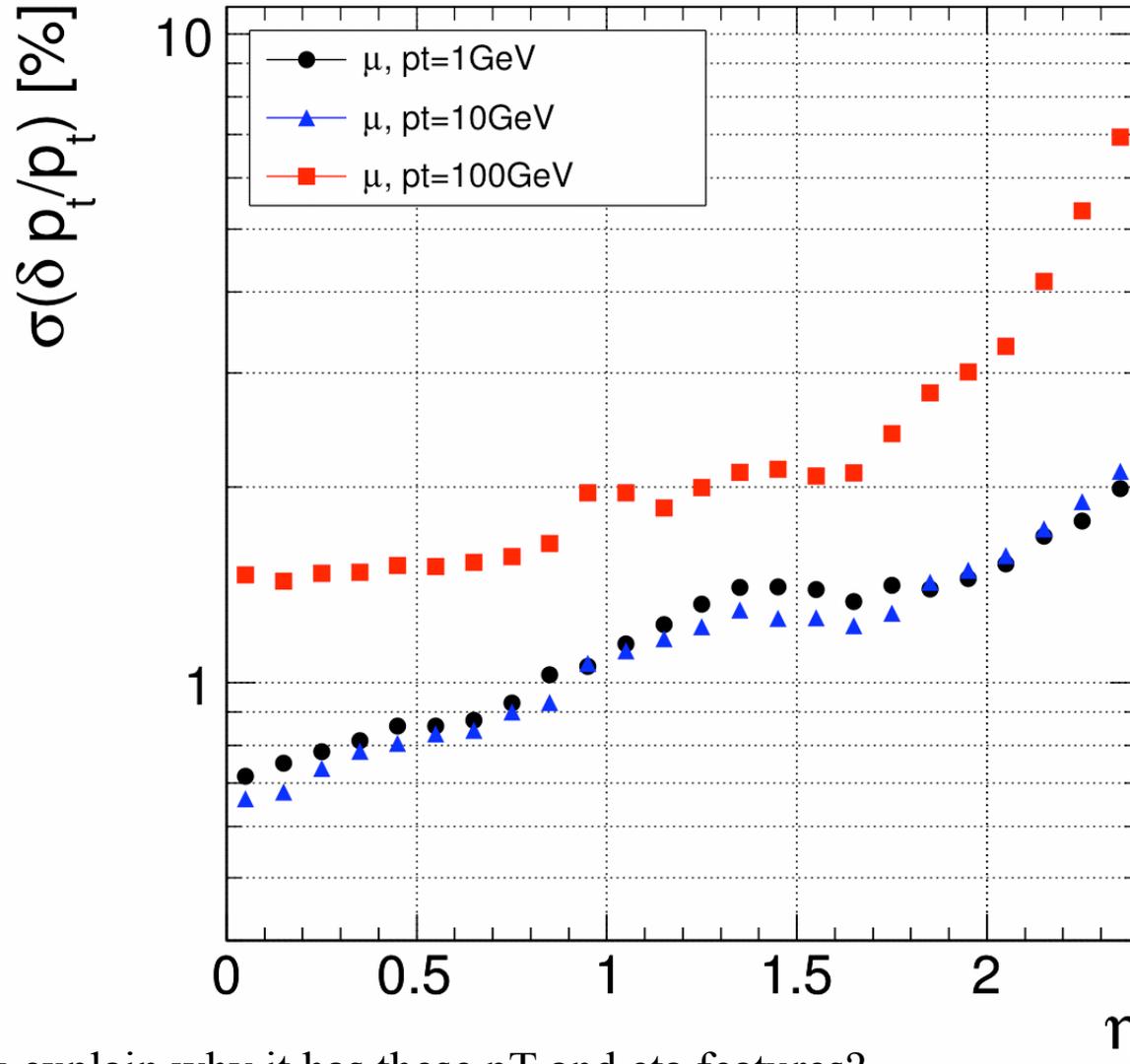
Momentum resolution

COT+SVX Momentum resolution Vs. P_T



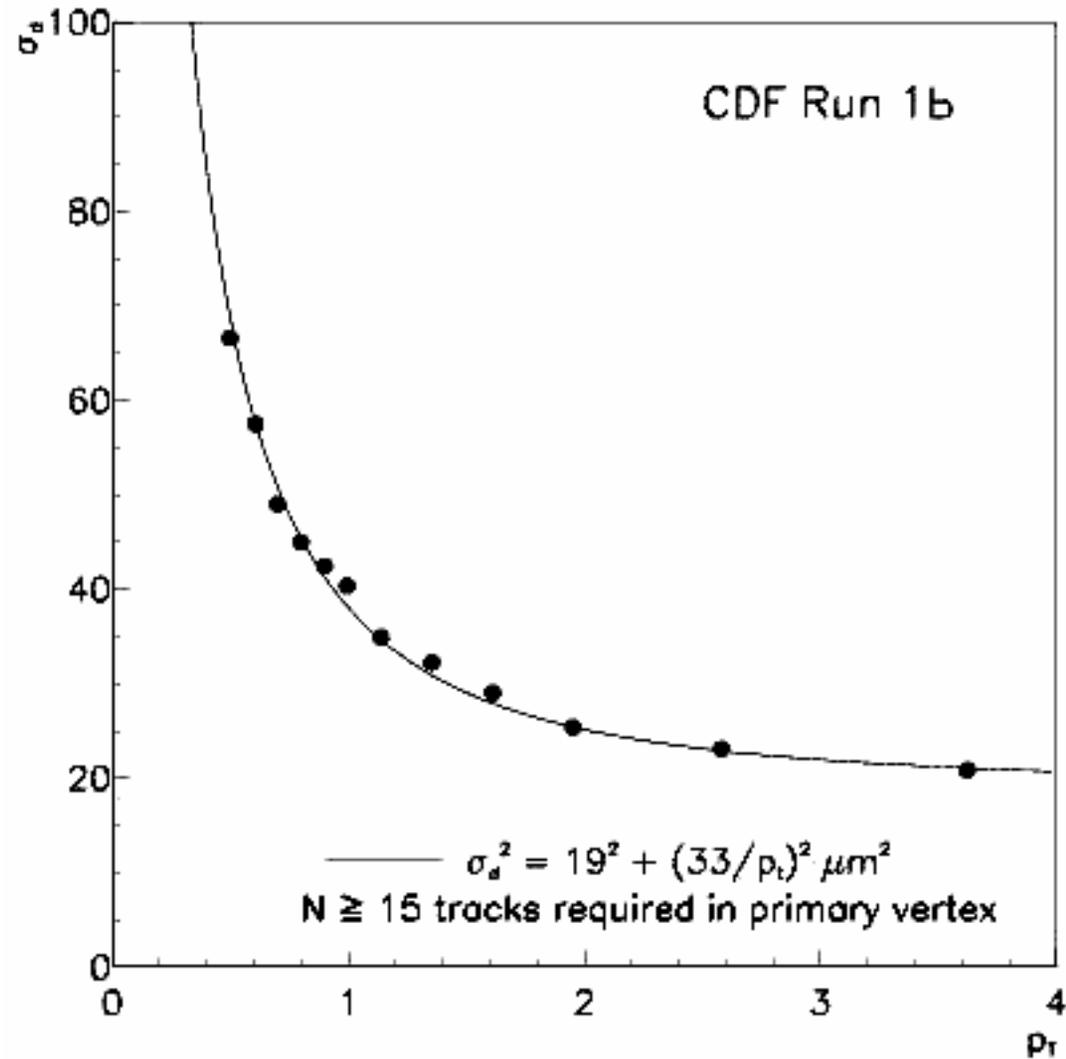
0.1% at
1 GeV

Momentum resolution



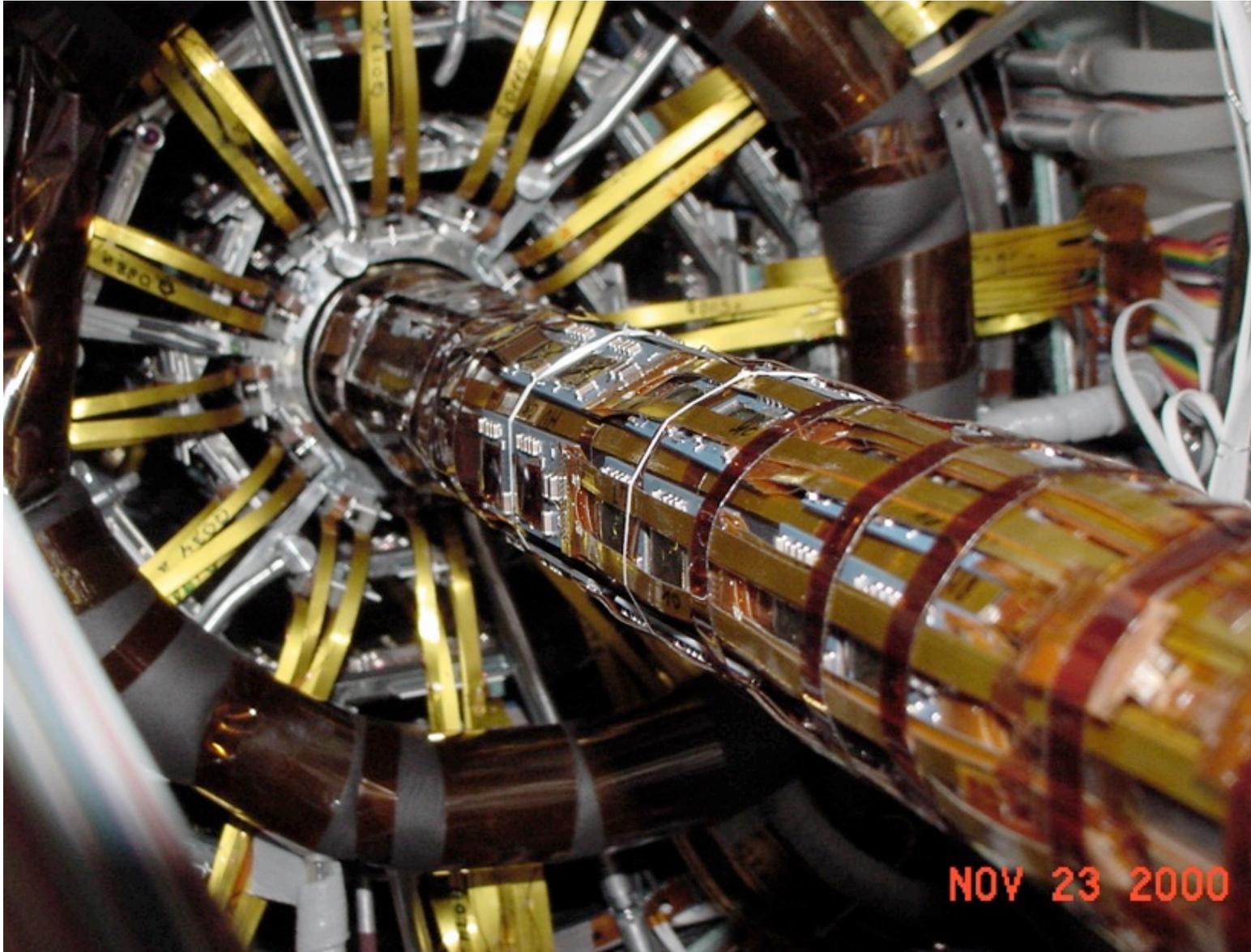
Check: Can you explain why it has these p_T and eta features?

Impact parameter resolution



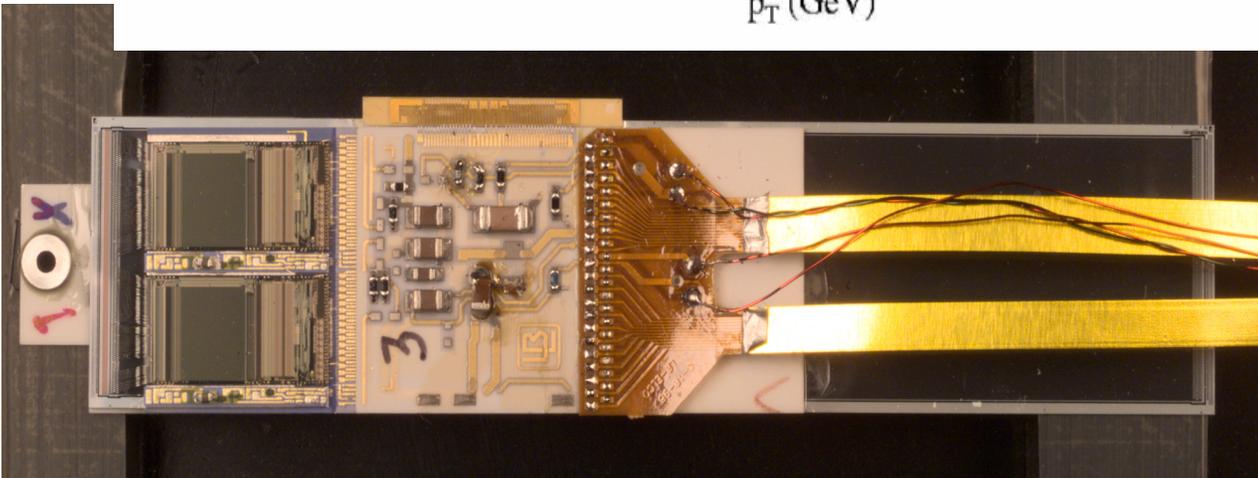
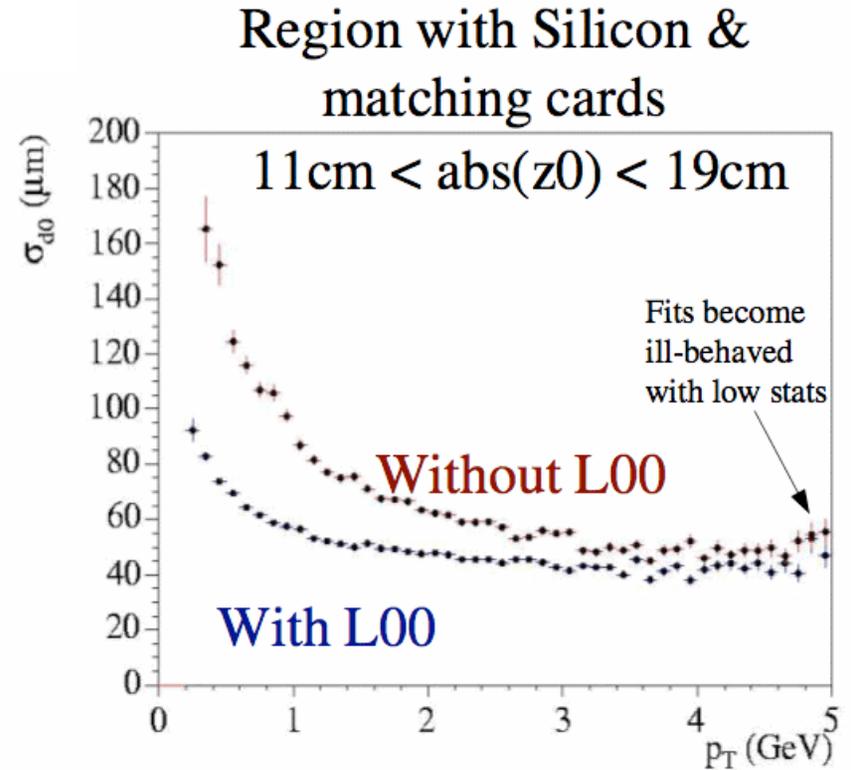
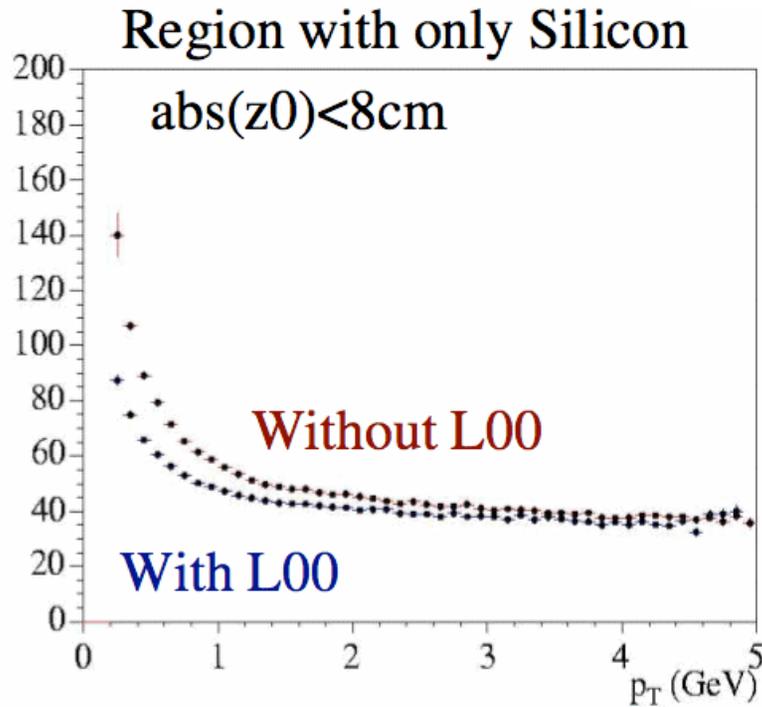
20 μm at high momentum, but MCS dominates at low momentum.

Impact parameter resolution

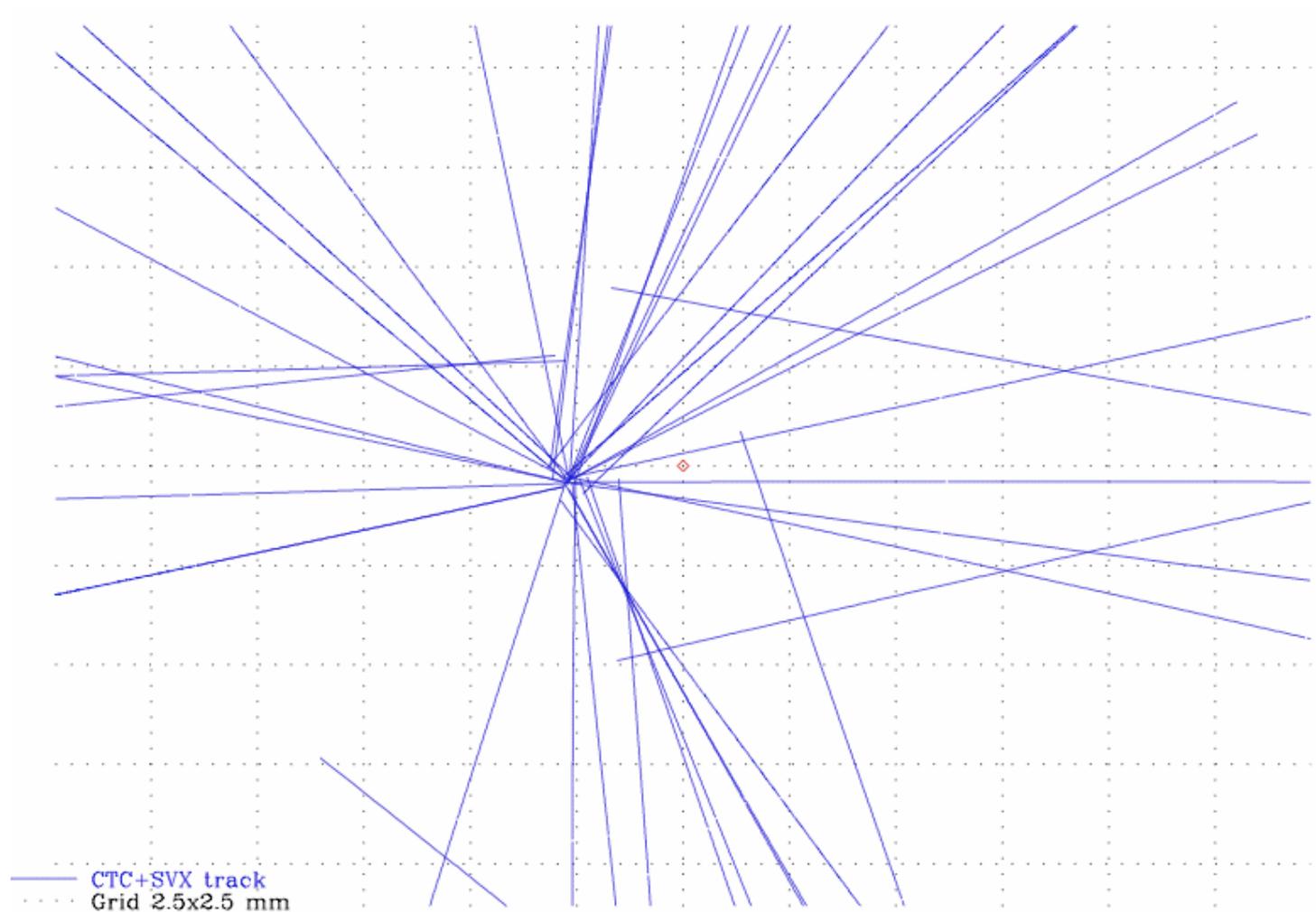


Aim for lowest radius and lowest mass.

Impact parameter resolution



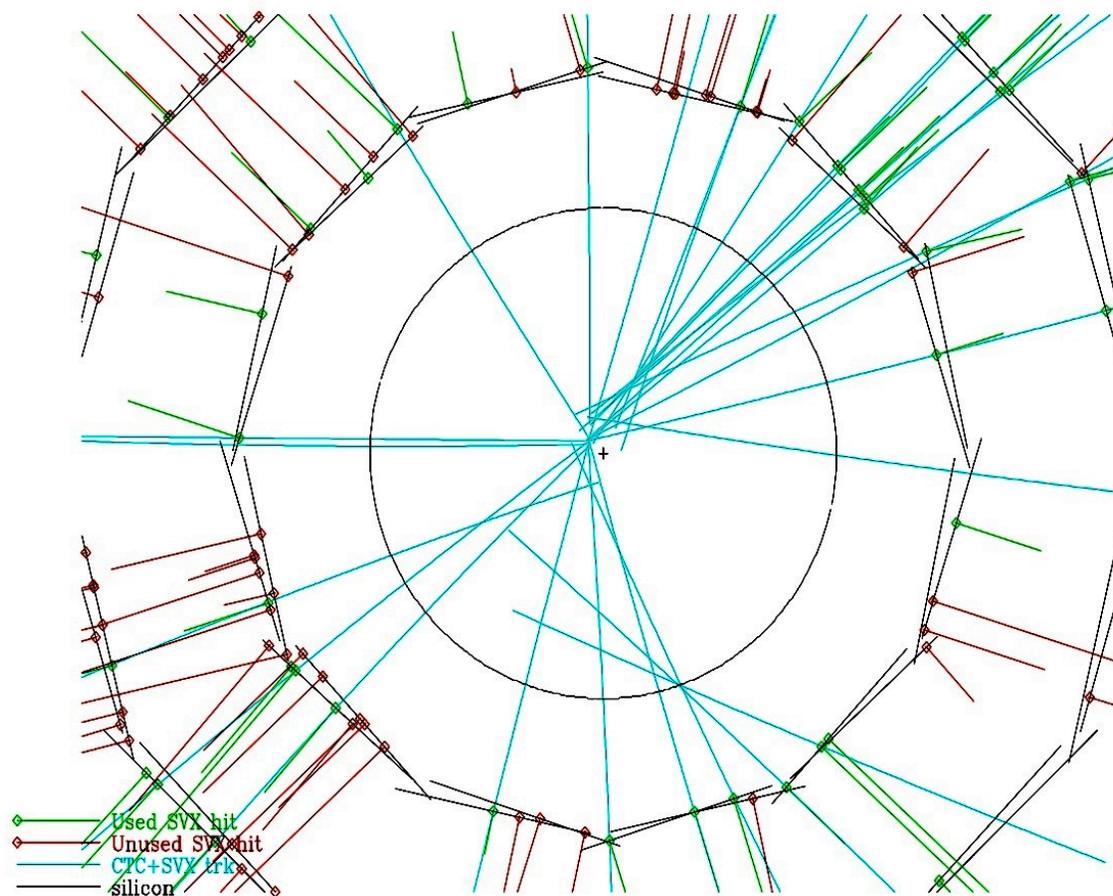
Vertexing



Find the vertex...

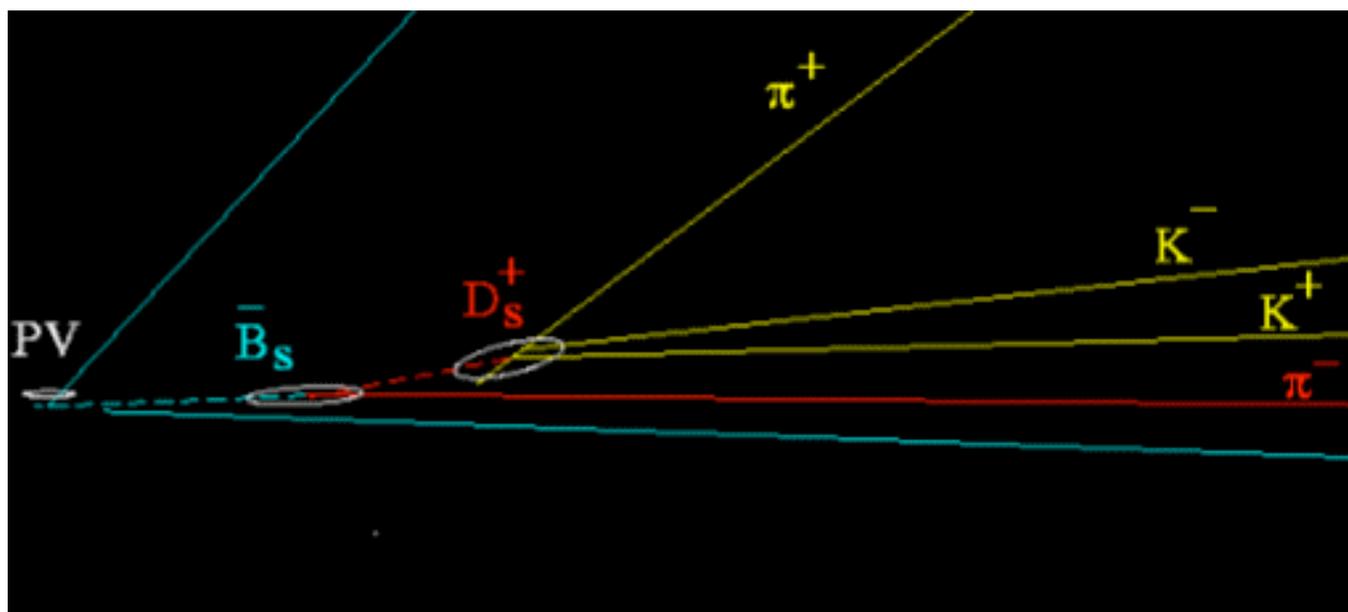
Vertexing

Run 64772 Evt 345288



Find the vertex...

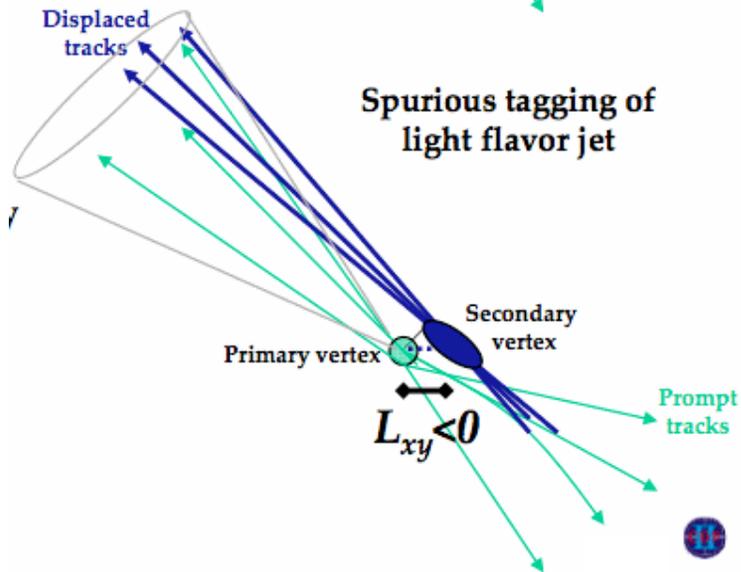
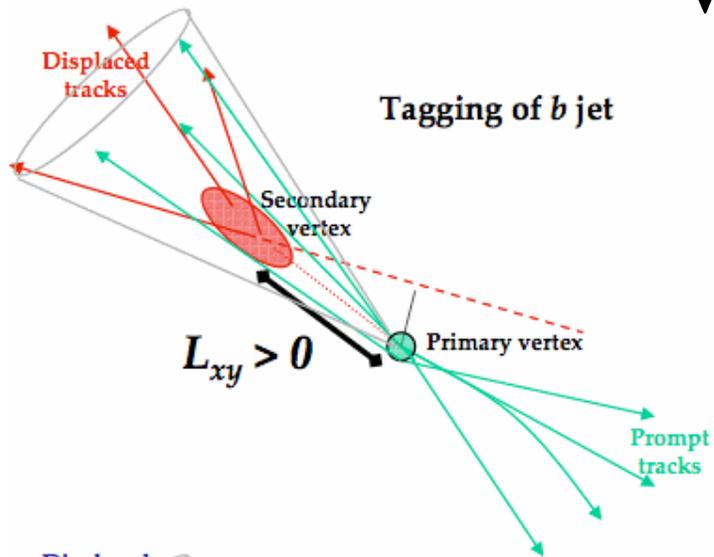
Vertexing



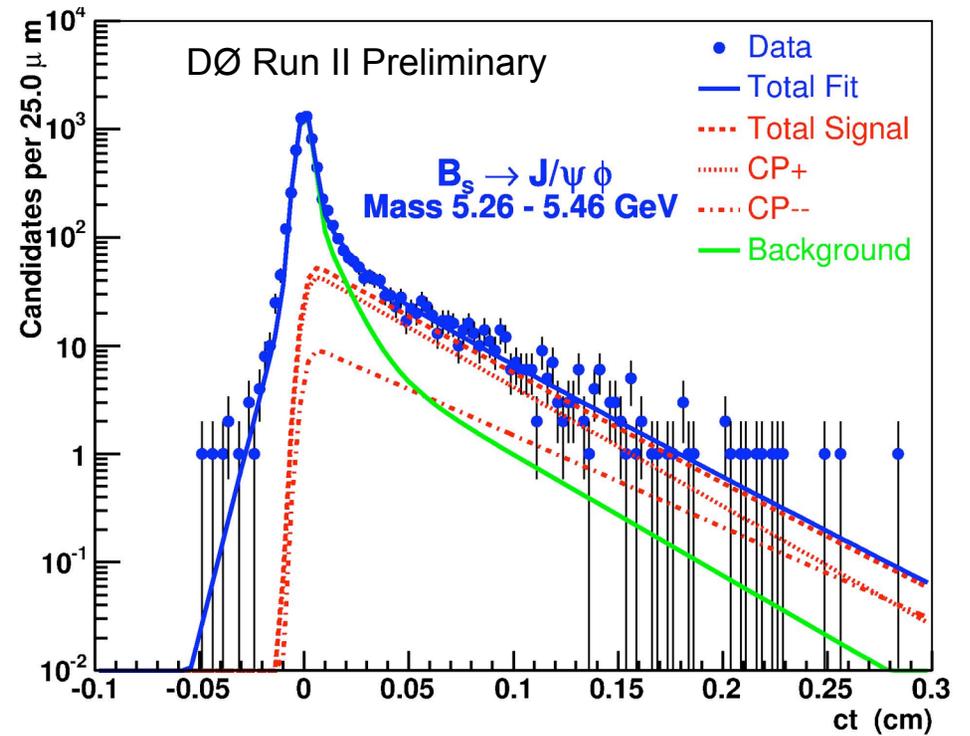
Aleph

Find the vertices...

Vertexing



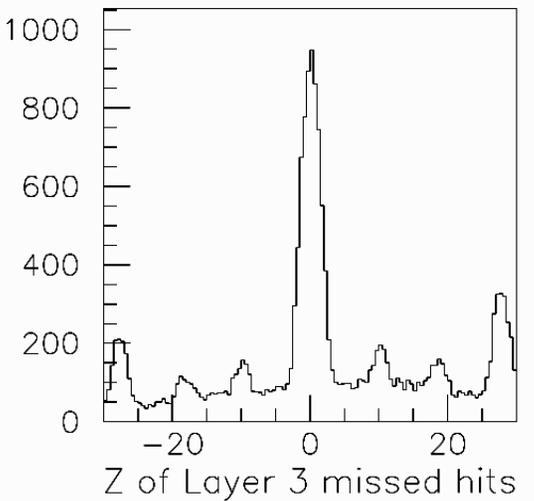
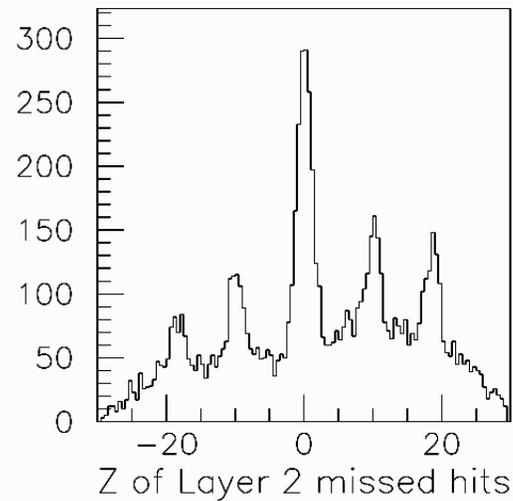
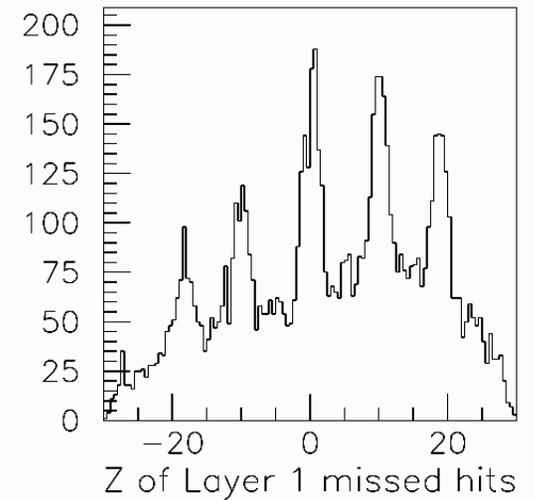
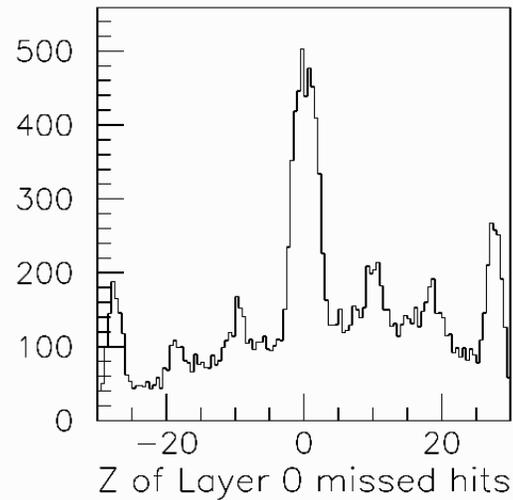
Find the vertices...



Track quality

Confirming track quality is important because one incorrect hit can have a huge effect!

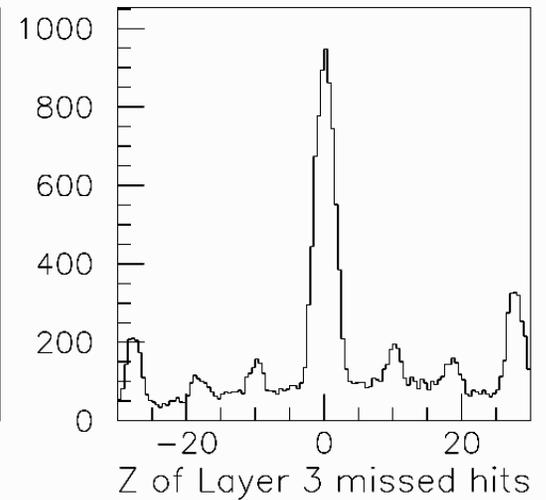
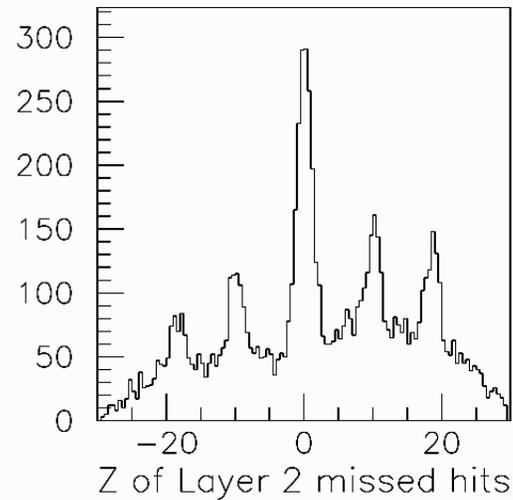
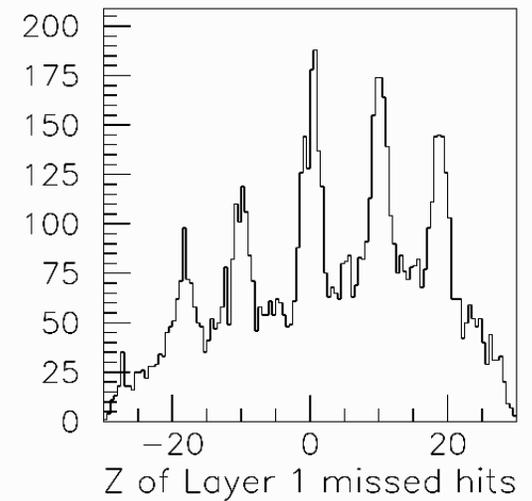
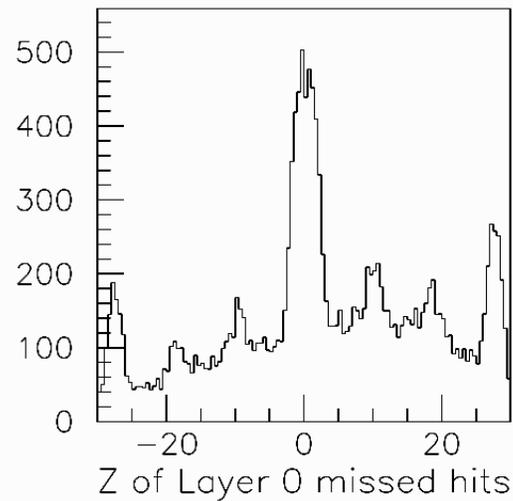
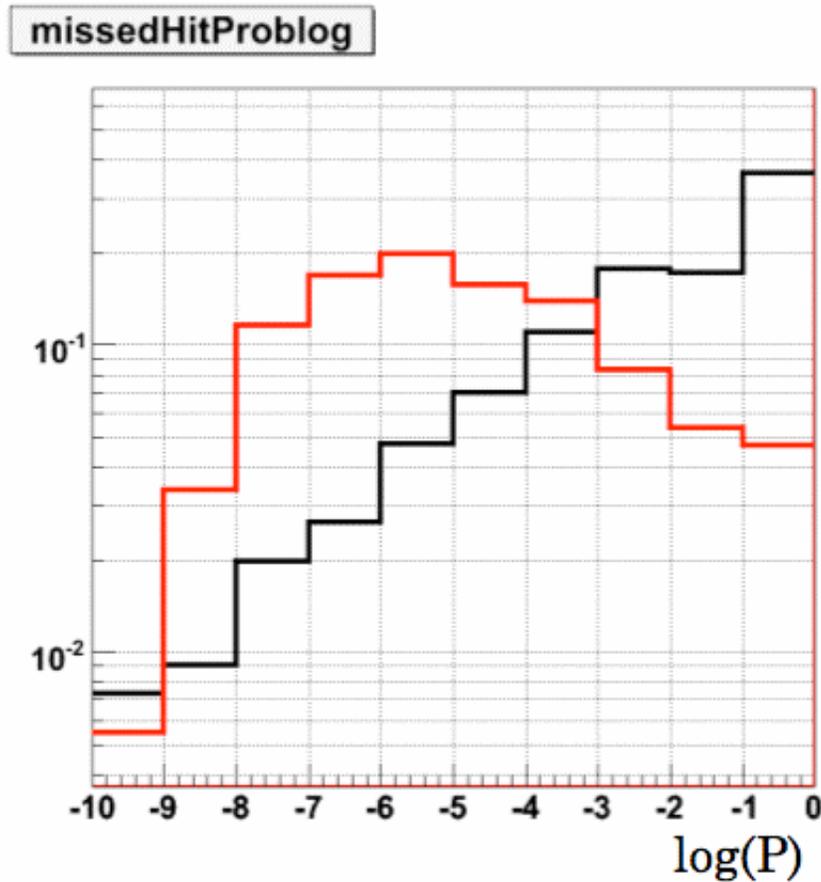
- A missed hit is as much a measurement as is a found hit.
- Charge is predictable



Track quality

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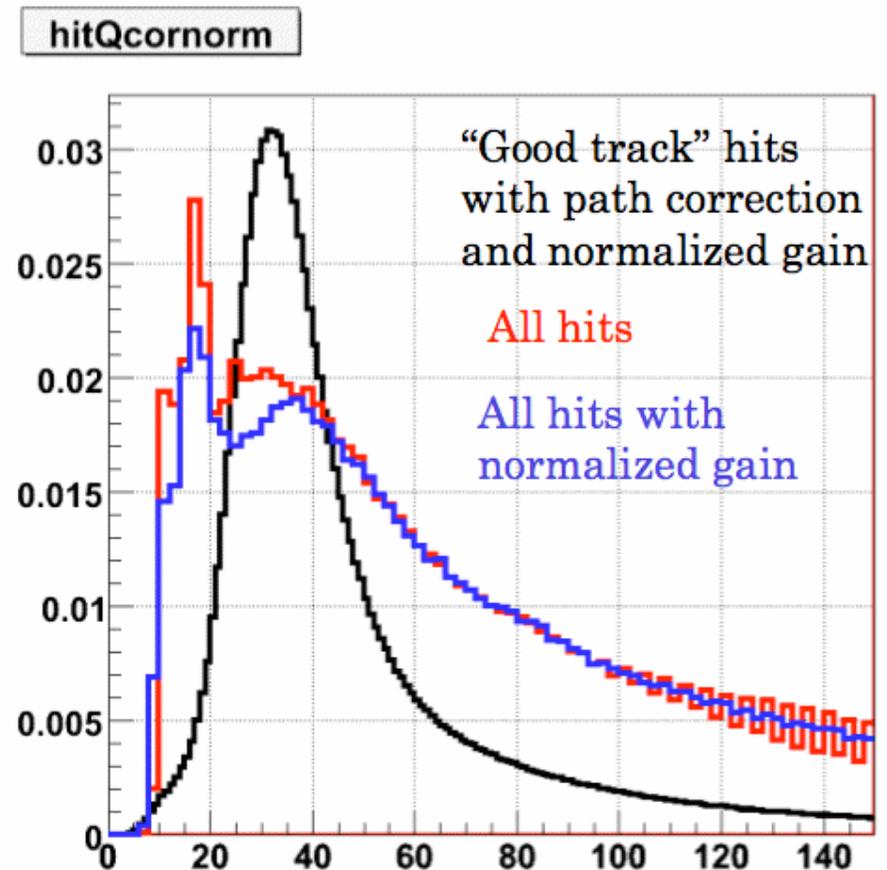
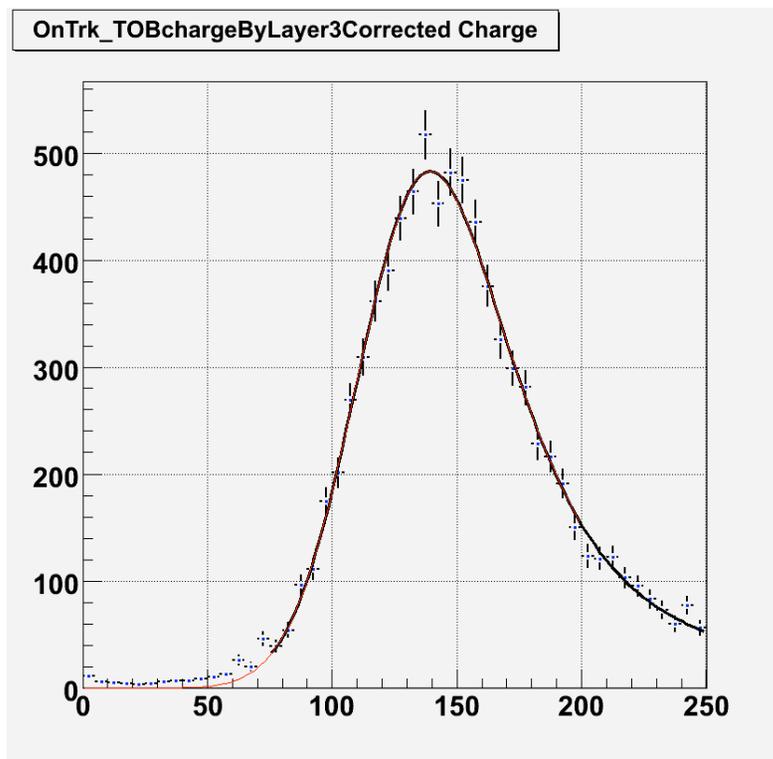
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Track quality

Confirming track quality is important because one incorrect hit can have a huge effect!

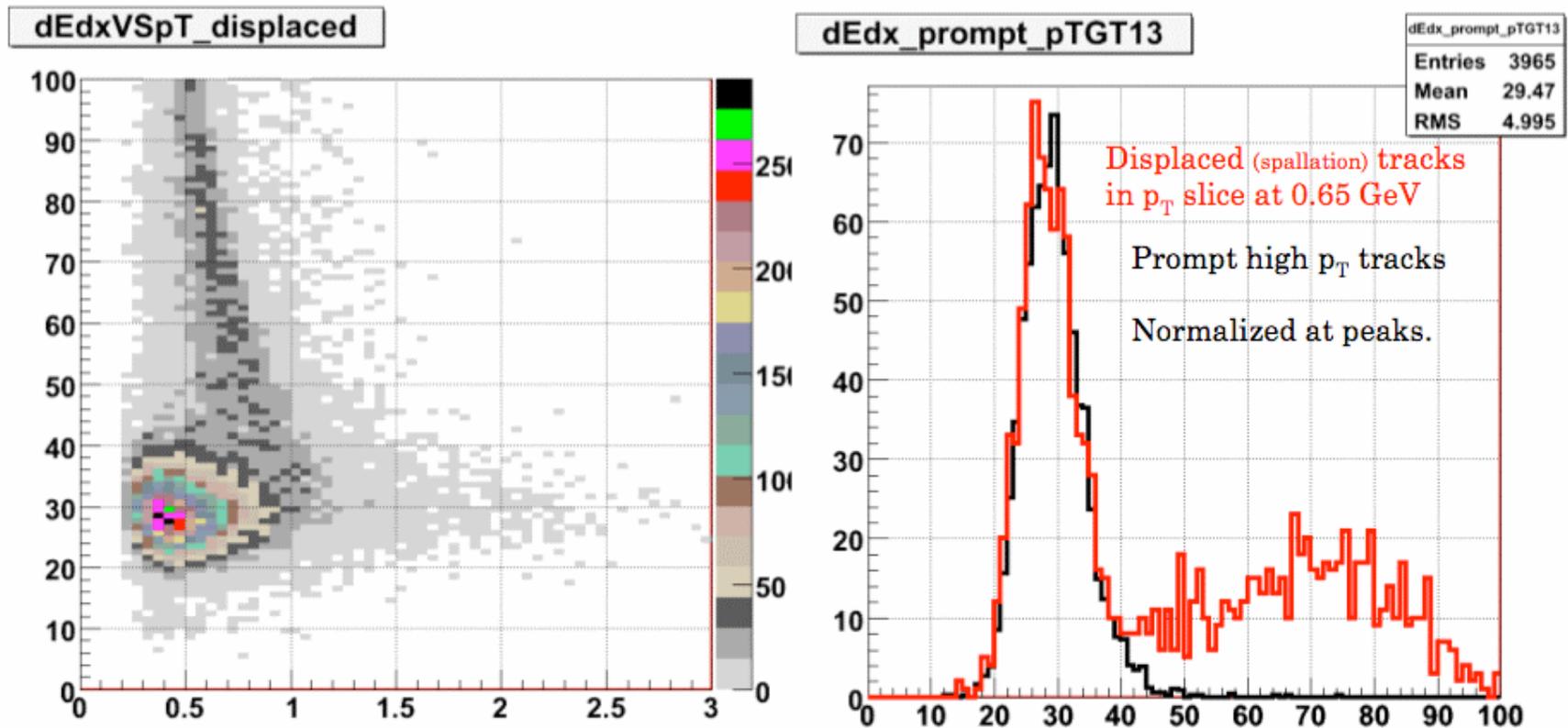
- A missed hit is as much a measurement as is a found hit.
- Charge is predictable



Track quality

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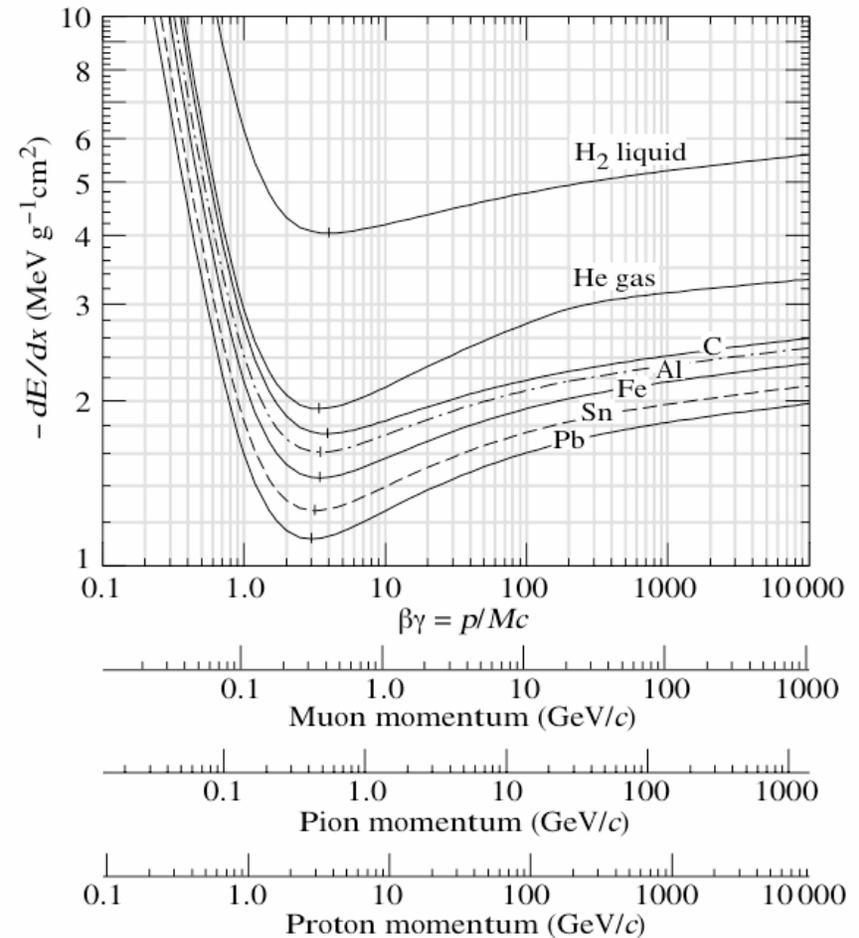
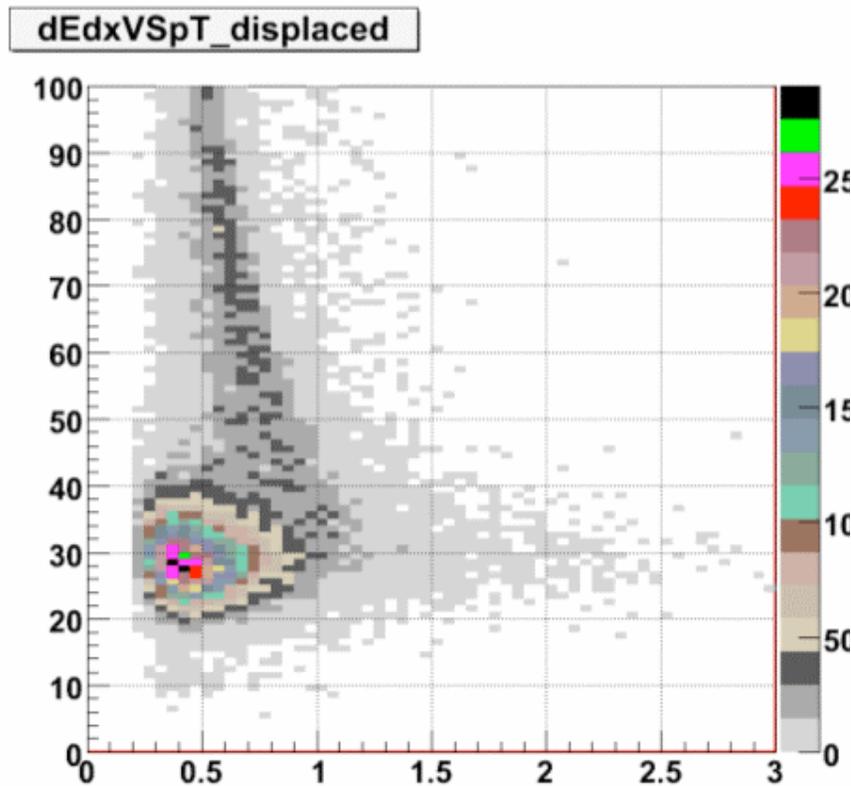
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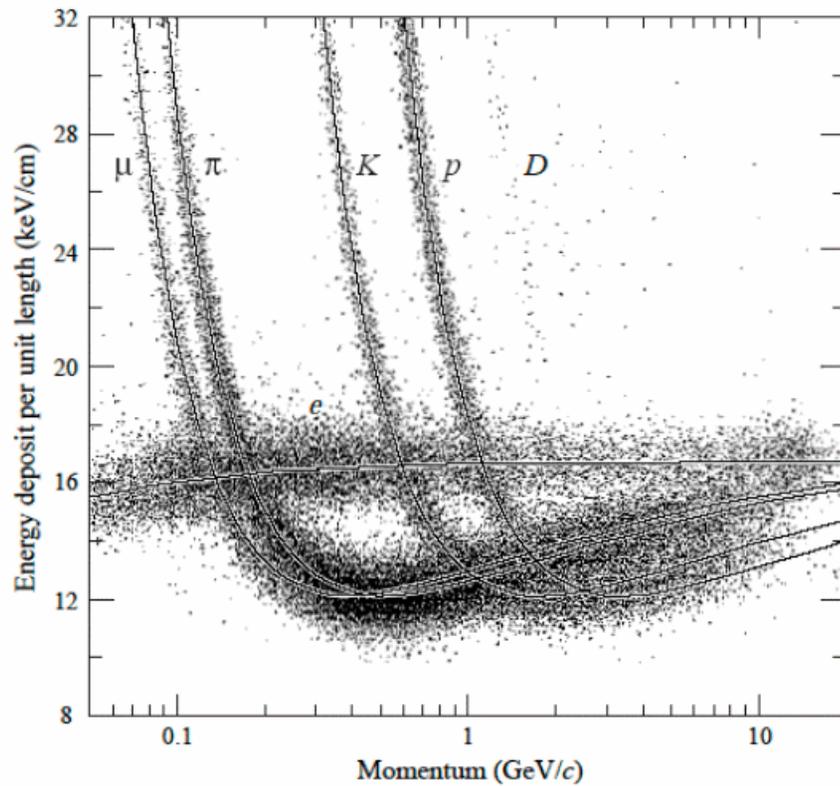
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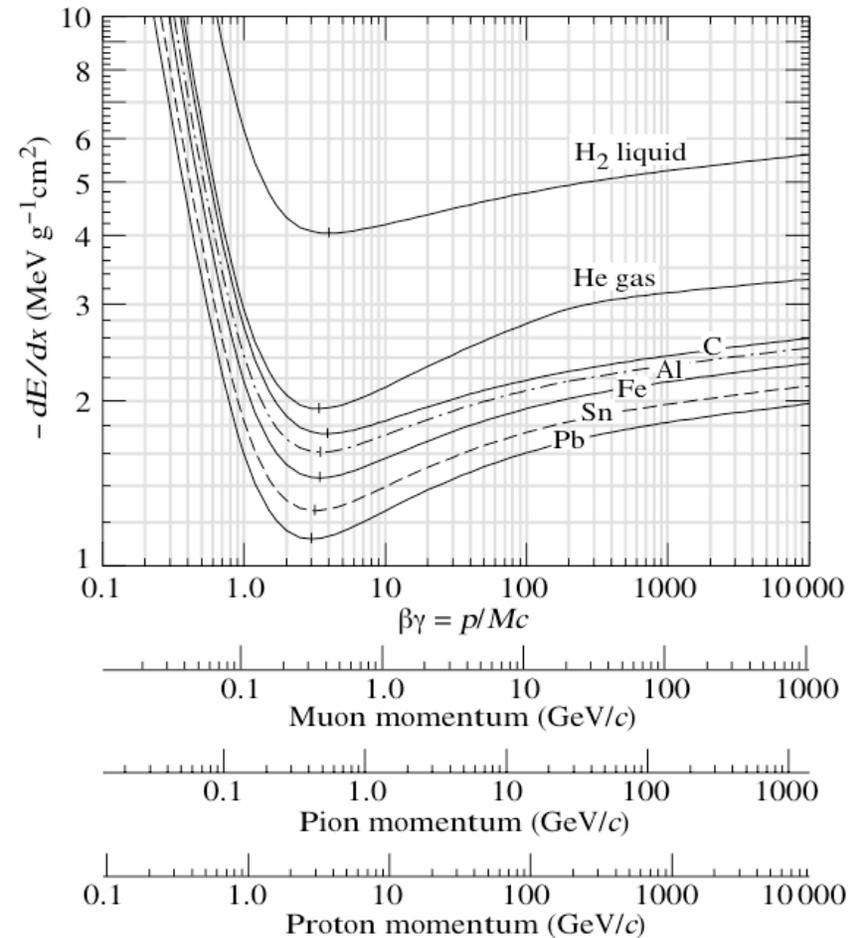
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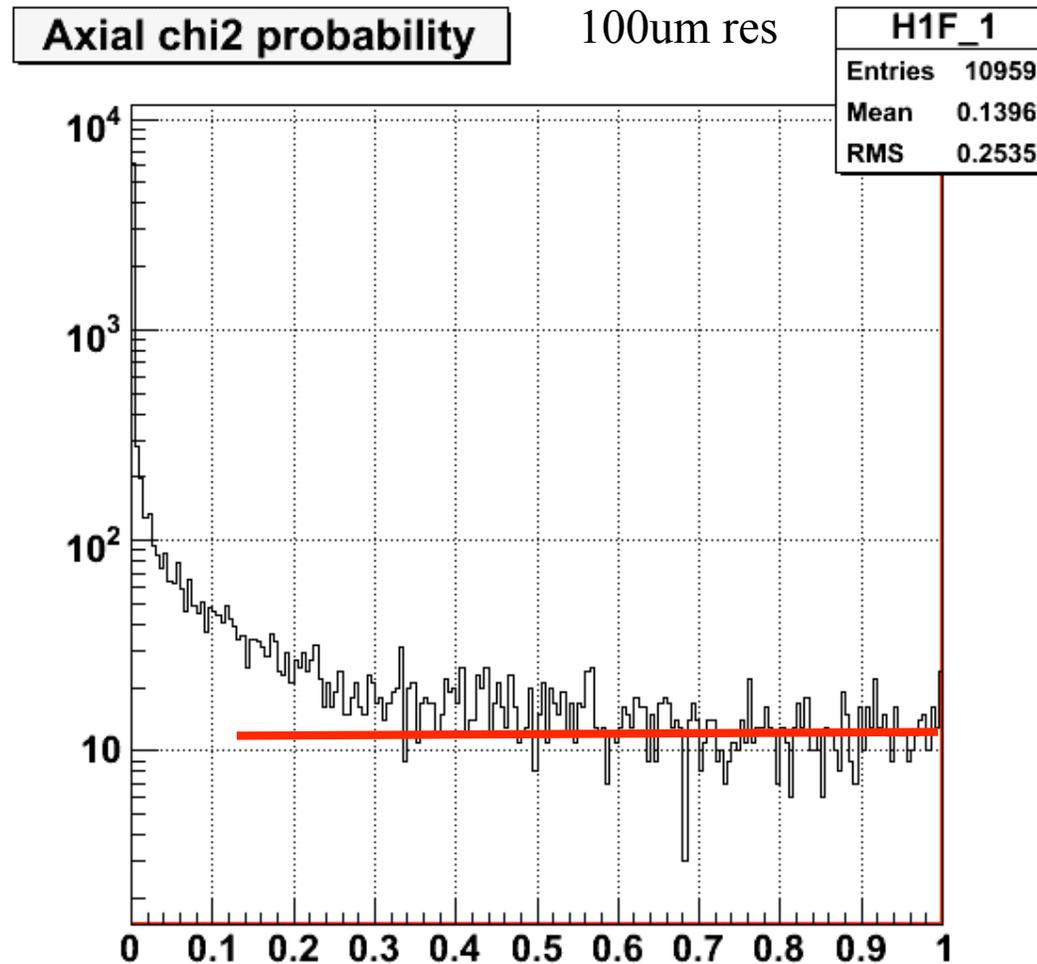


Opal (?)



χ^2 probability

If the errors are calculated correctly, the χ^2 probability should be reasonably flat.



This plot is from cosmics taken at CMS recently without a magnetic field.
Can you explain the very low probability entries?

...Possible Algorithms...

Seed from other measurement, e.g., electron or muon

Seed from subset of hits.

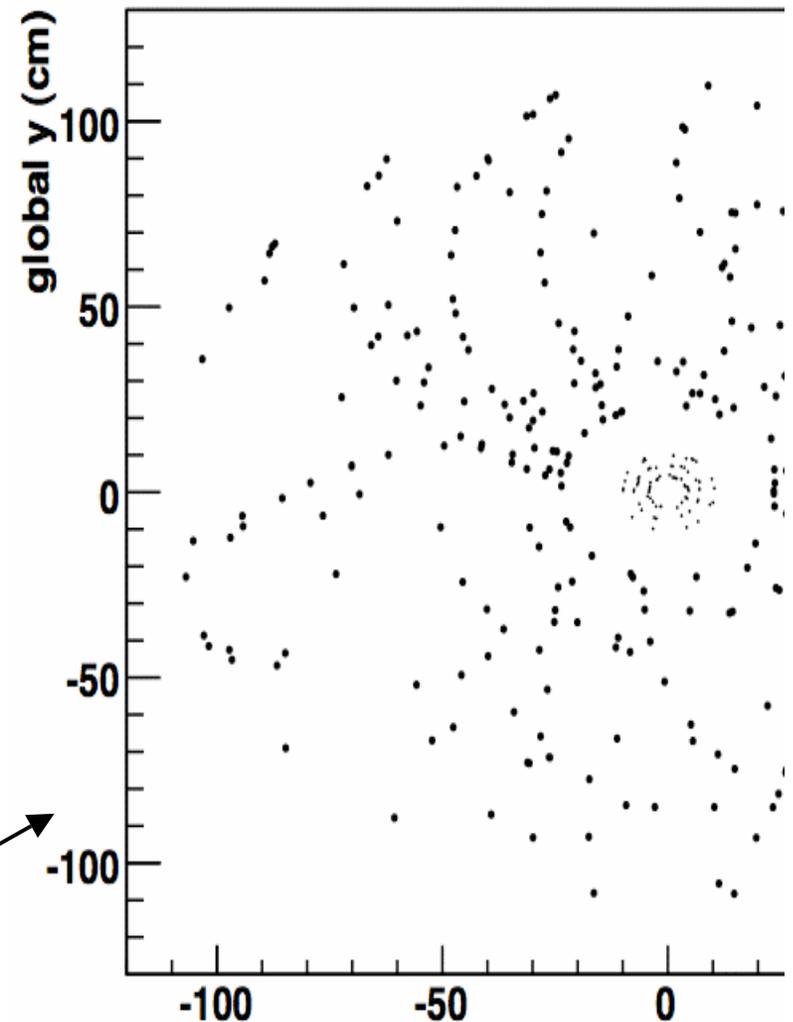
Outer hits?

Inner hits?

Combinatorics of all hits

Remove used hits

Work pretty well for this.



...Possible Algorithms...

Seed from other measurement, e.g., electron or muon

Seed from subset of hits.

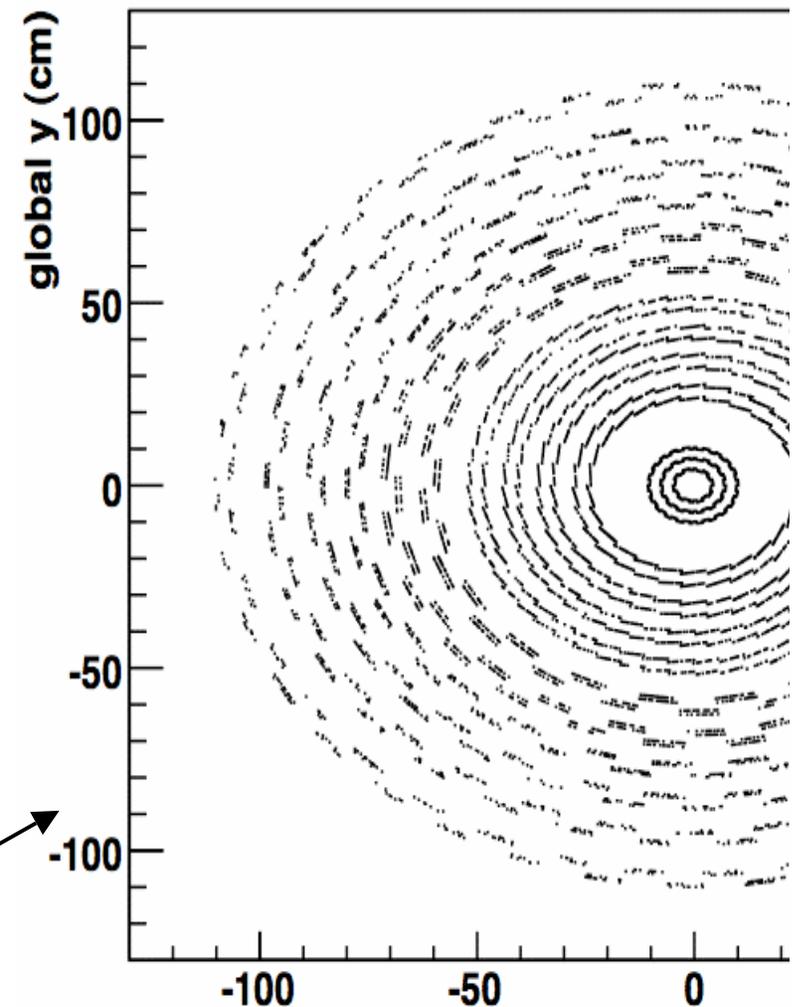
Outer hits?

Inner hits?

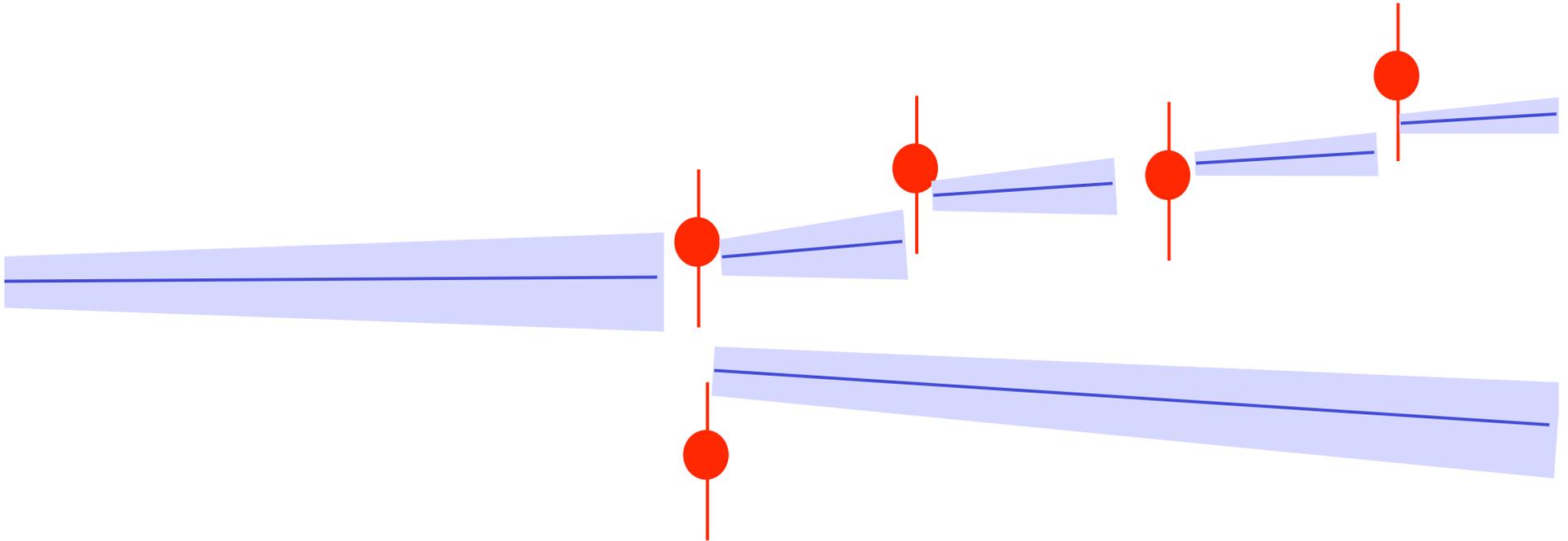
Combinatorics of all hits

Remove used hits

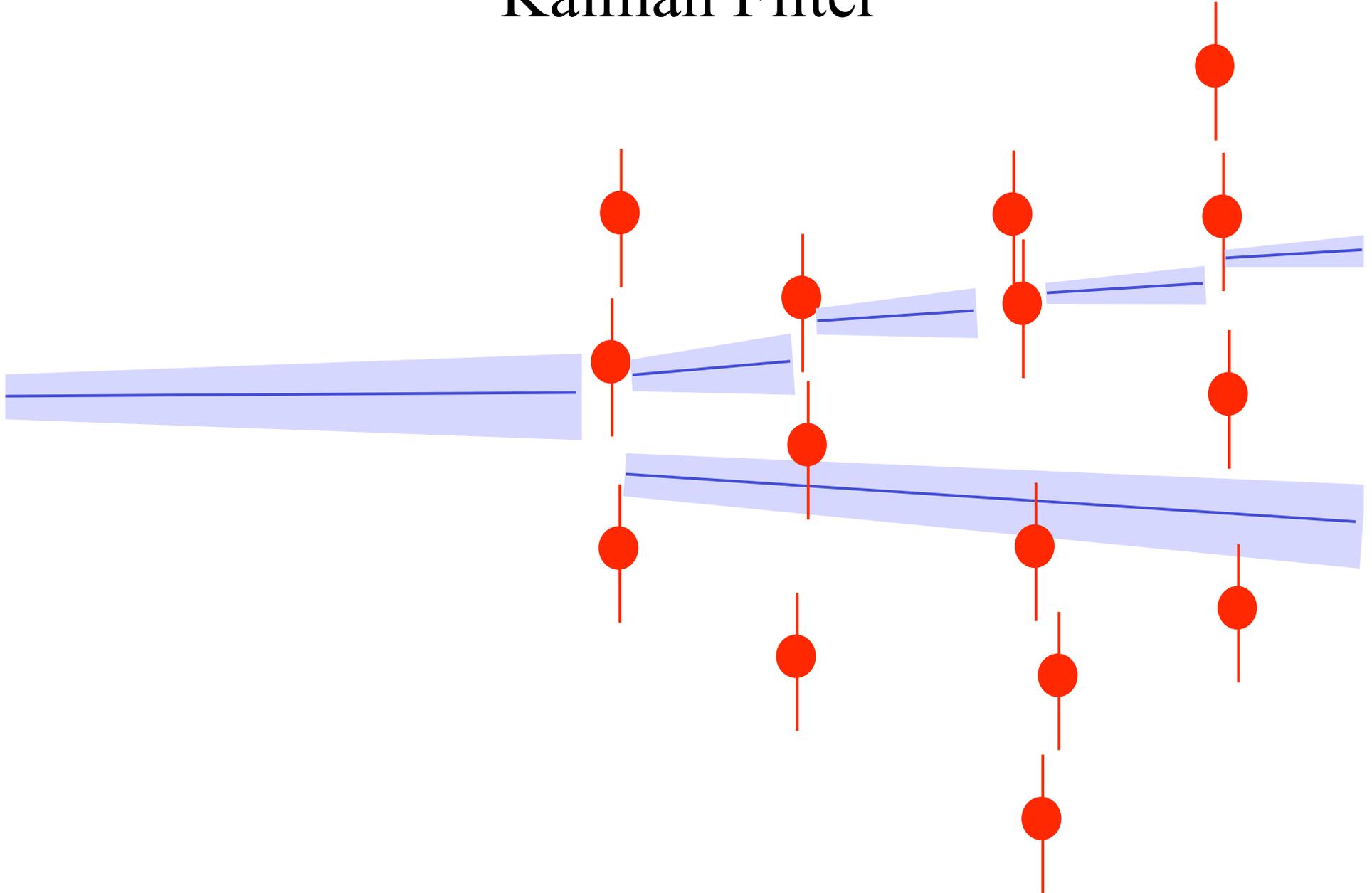
Challenging for this.



Kalman Filter

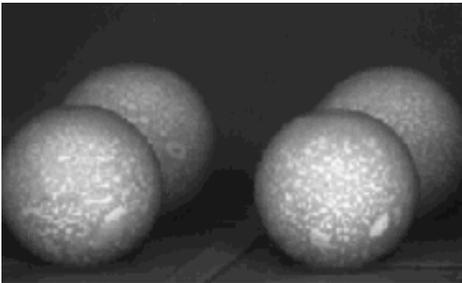
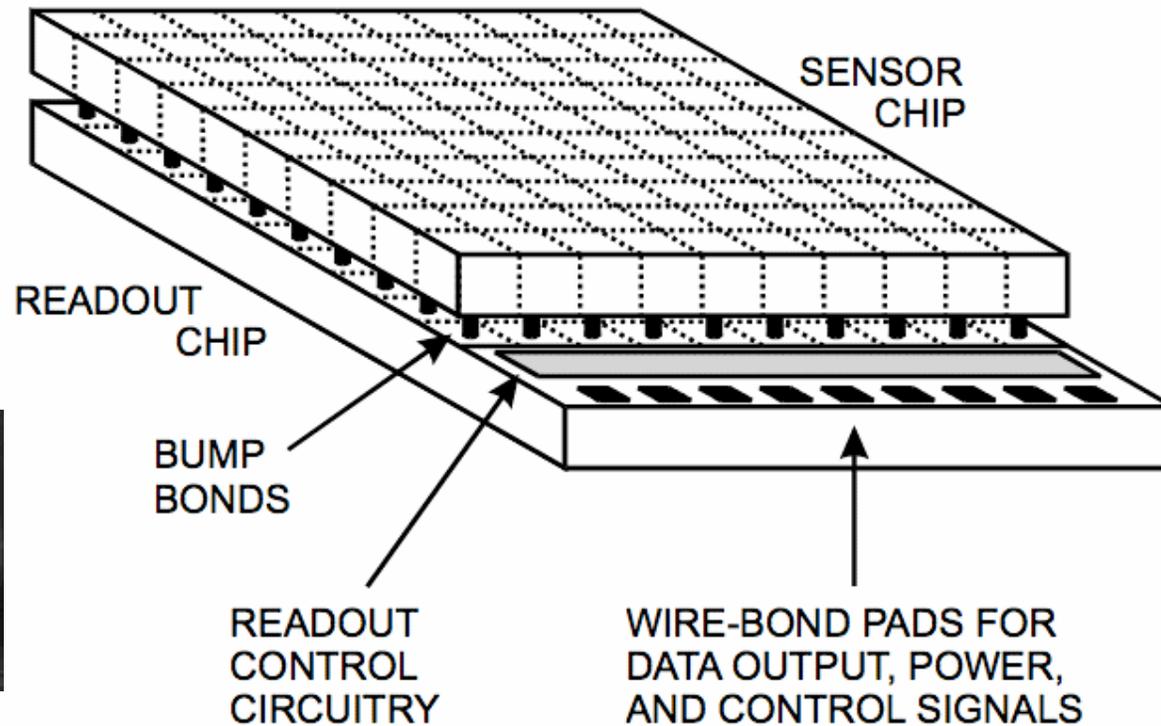


Kalman Filter



3D measurements: Pixels

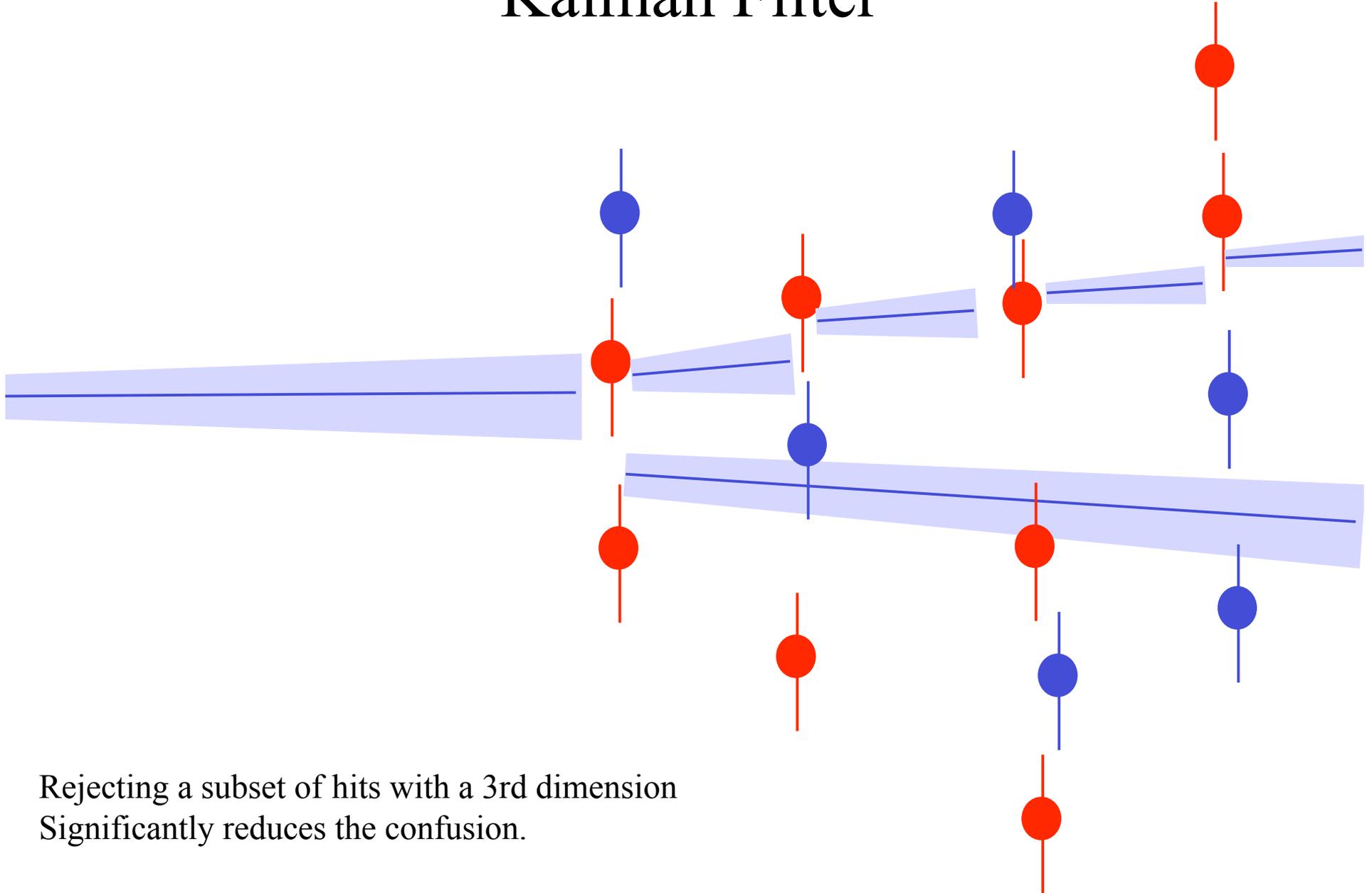
Two precise and unambiguous measurements in the same sensor!



But, motivated more by granularity (for robust track finding) than by resolution...

Helmut Spieler, "Semiconductor Detector Systems"

Kalman Filter



Rejecting a subset of hits with a 3rd dimension
Significantly reduces the confusion.

And pixels can give seeds that are precise in 3 dimensions.

Pixel challenges

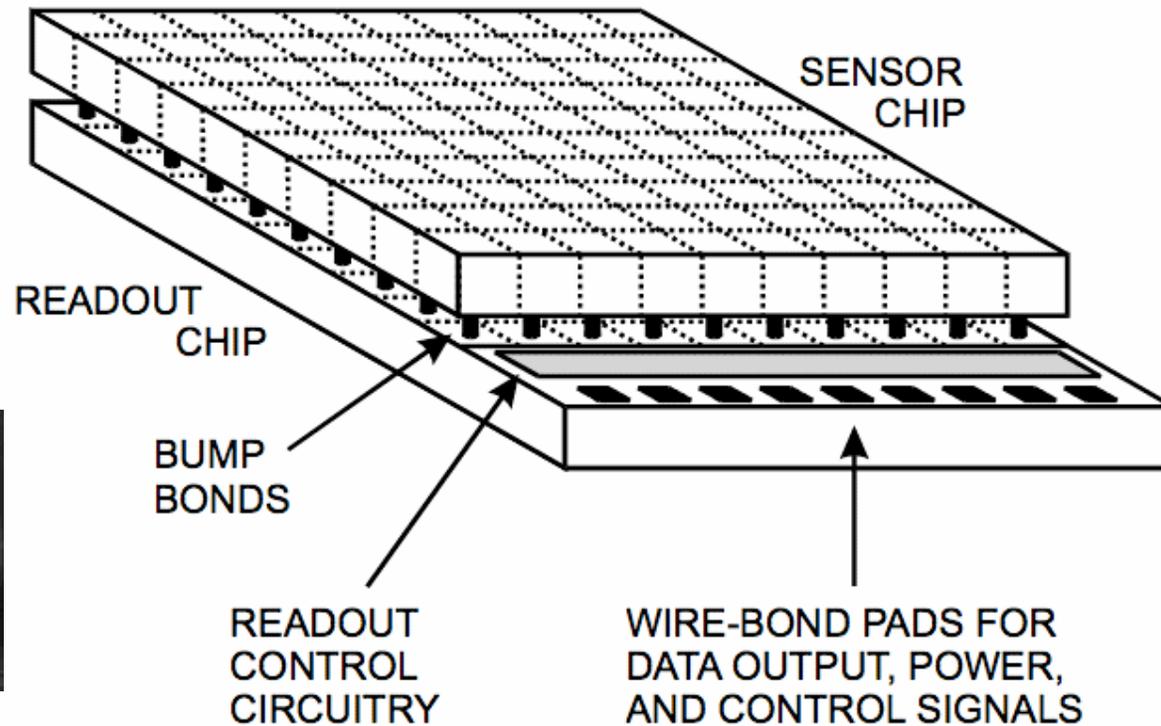
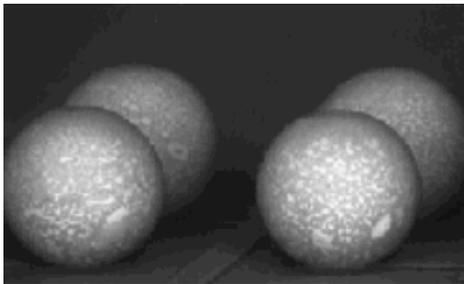
The many connection challenge is squared.

Internal electronics

Cooling

Material

Mechanically hard



Helmut Spieler, “Semiconductor Detector Systems”

Pixel challenges

The many connection challenge is squared.

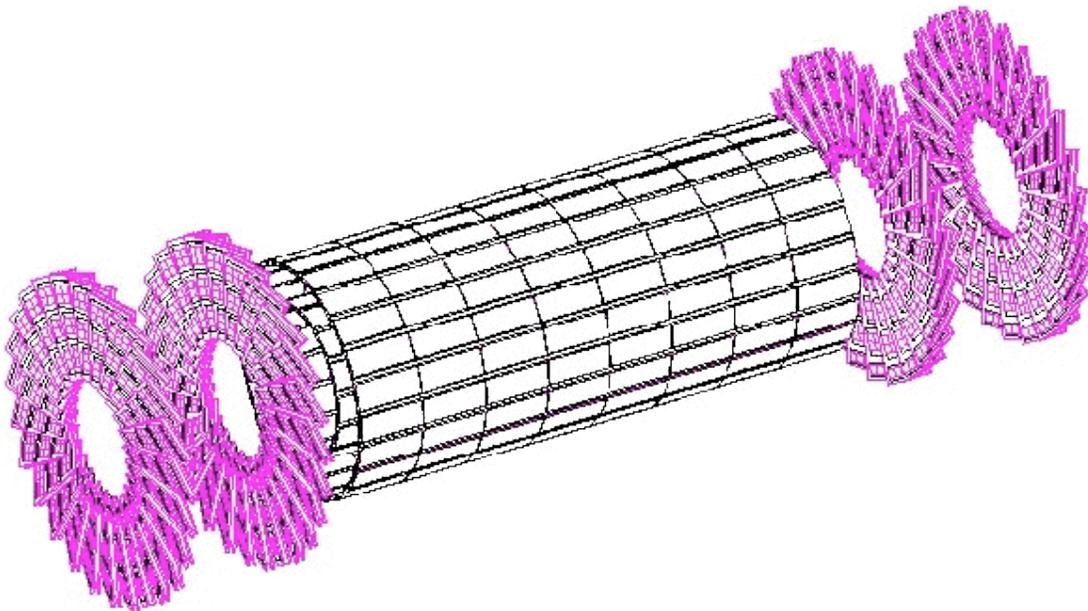
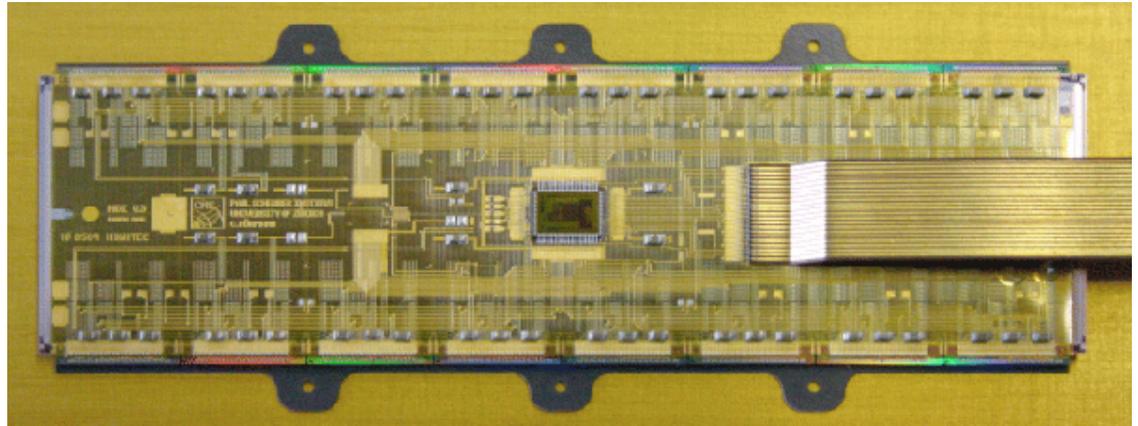
Internal electronics

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Mechanically hard

Complex



Pixel challenges

The many connection challenge is squared.

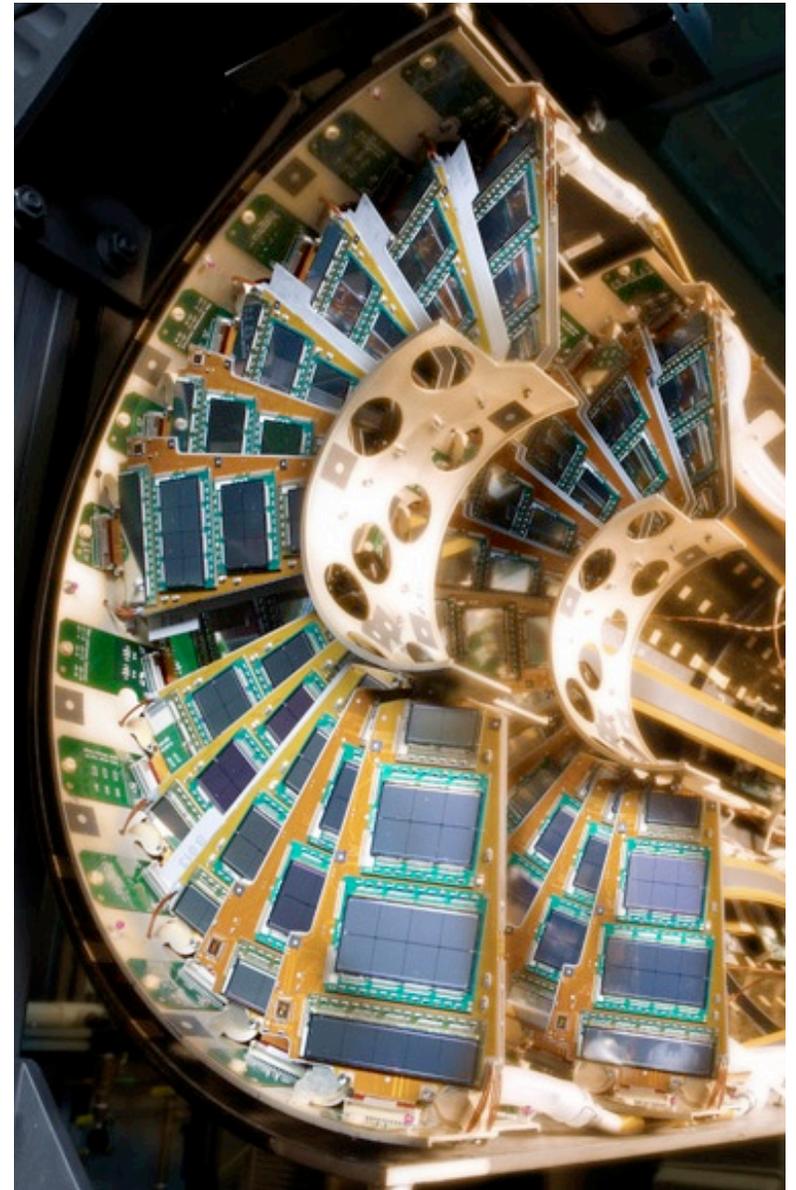
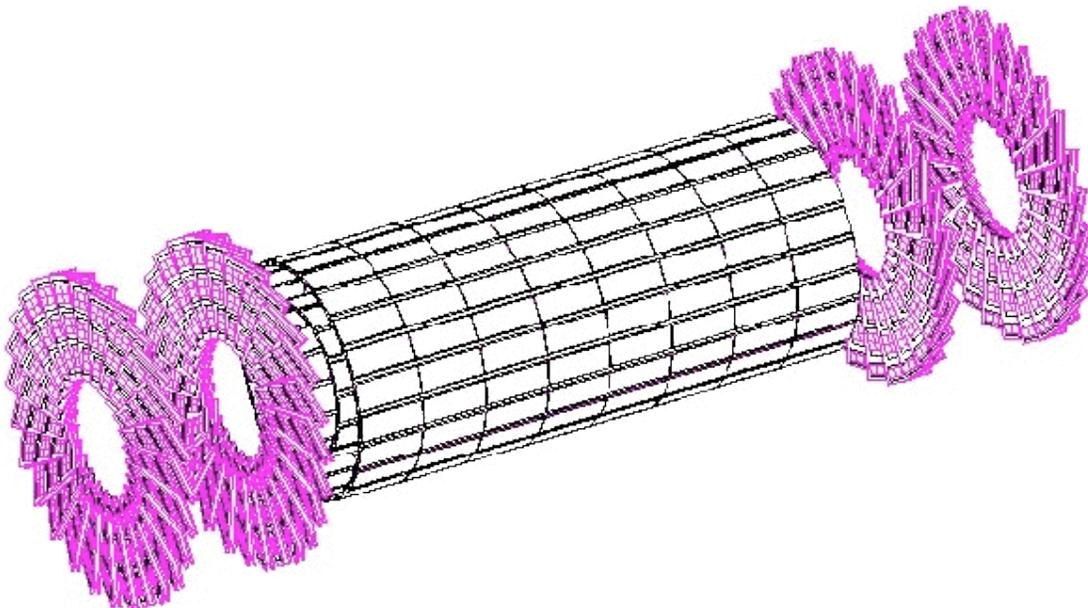
Internal electronics

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Mechanically hard

Complex



Design Constraints

Large radius:

- Better momentum resolution
- Less confusion
- Cost scales as R^2 .

Small radius:

- Better impact parameter resolution
- More confusion

Large Magnetic field:

- Better momentum resolution
- Cost
- Curler confusion

Small hit resolution:

- Better track resolution
though MCS and mis-reco may dominate.
- Cost

Low mass:

- Better resolution at low momentum
- Mechanically difficult

Fine granularity (both dimensions):

- Less confusion
- Cost
- Complexity
- Material

Possible Designs

Wire chamber at high radius

Large radius

Low cost

Low mass

Many measurements

Silicon strip detector at high radius

Large radius

Low-ish cost

Low-ish mass

Many-ish measurements

Silicon at small radius

High precision for impact parameter

Try to keep it light

Enough layers to match seeds

Pixels at small radius:

High precision in both dimensions

Enough layers to match (or make) seeds

Possible Designs

Wire chamber at high radius

- Large radius
- Low cost
- Low mass
- Many measurements

Silicon strip detector at high radius

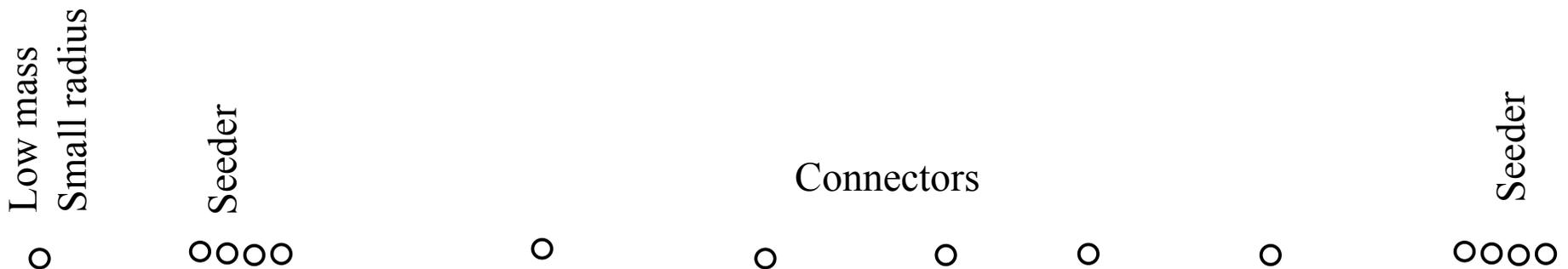
- Large radius
- Low-ish cost
- Low-ish mass
- Many-ish measurements

Silicon at small radius

- High precision for impact parameter
- Try to keep it light
- Enough layers to match seeds

Pixels at small radius:

- High precision in both dimensions
- Enough layers to match (or make) seeds



Please make it all pixels...or at least 1mm cell with 20 micron resolution
...for less than \$50M and at 1% X0 per hit....and...

Next time...

What it takes to make it work

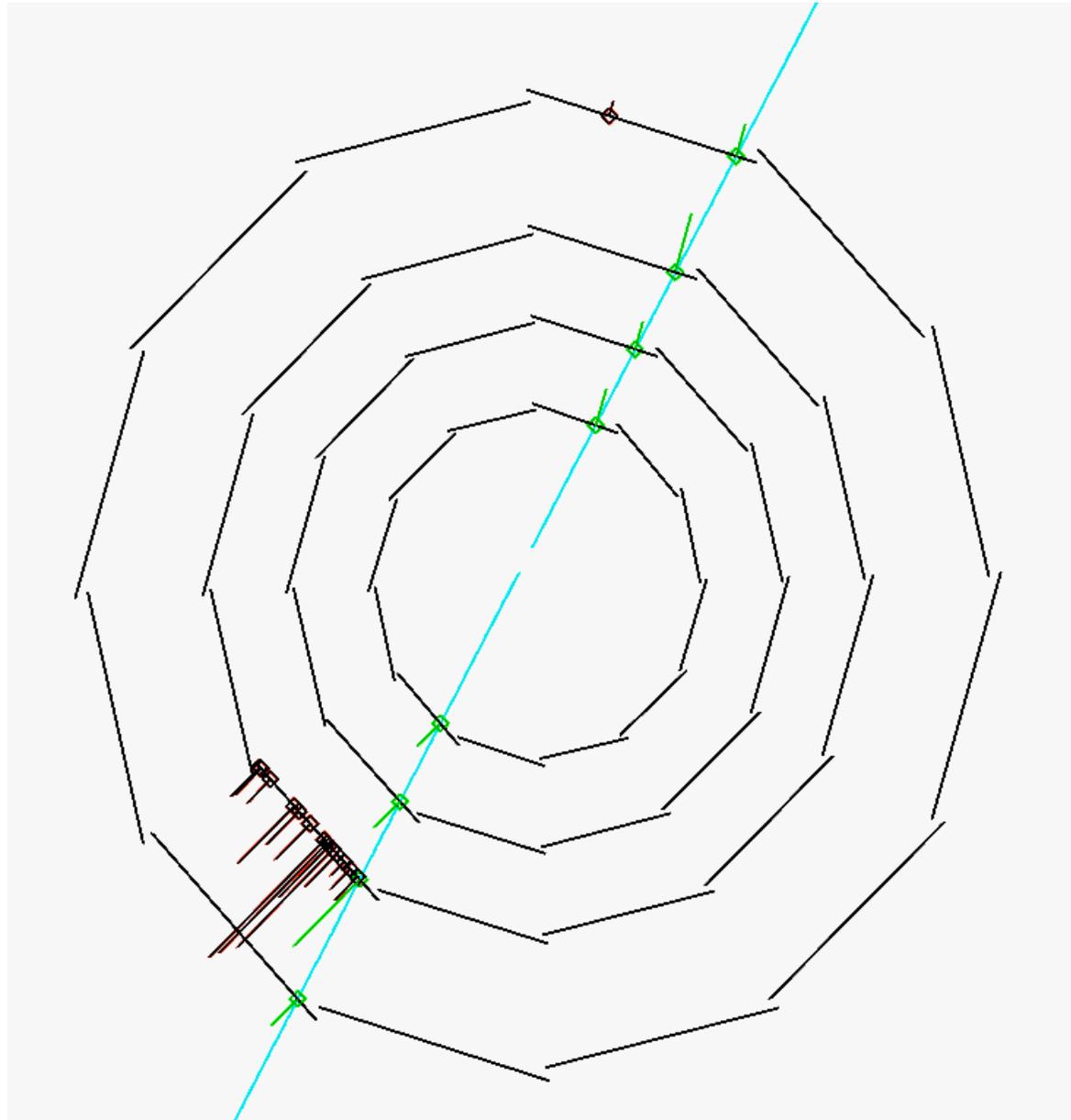
What will try to kill it

Bibliography

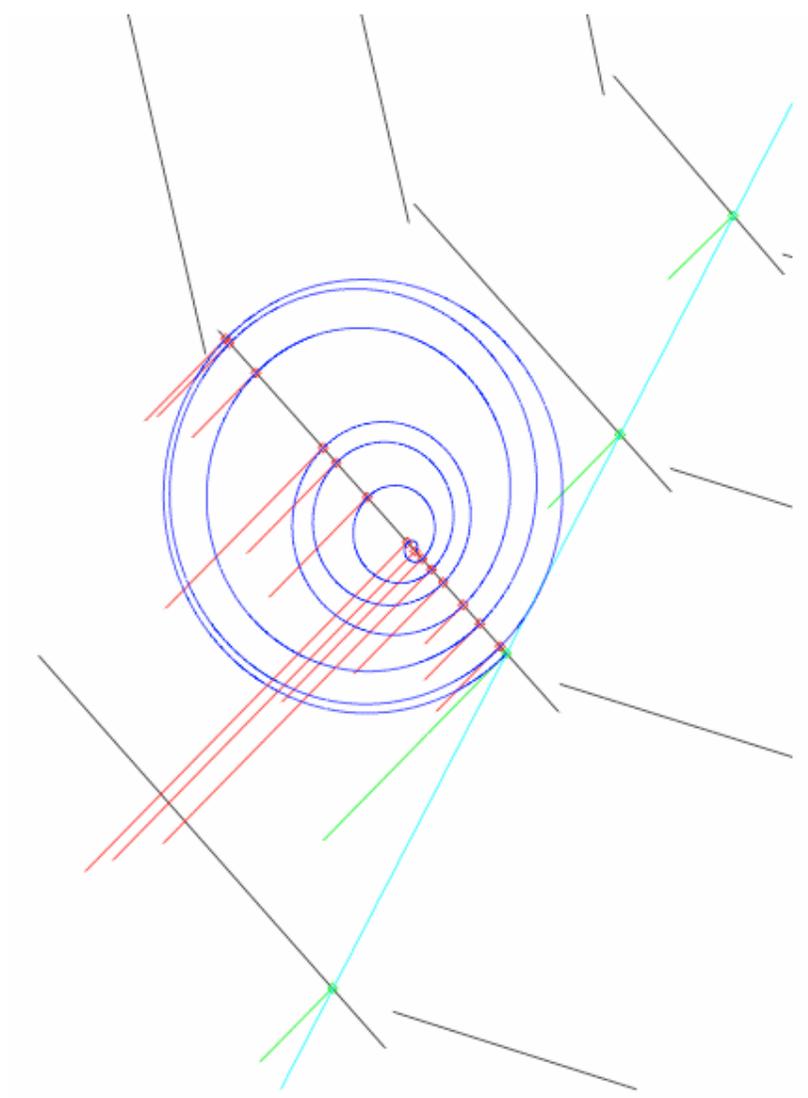
- Gino Bolla, UTeV seminar
- Guido Tonelli, Tracking at the LHC, SLAC Summer Institute 2006
- Aaron Dominguez, HCPSS06 Lecture on Tracking
- CMS Technical Design Report
- CDF Technical Design Report
- Daniella Bortoletto, 11th Vienna Conference on Instrumentation, Feb. 2007
- Helmut Spieler, “Semiconductor Detector Systems”
- Hans Wenzel, “Tracking in the SVX”, CDF Note 1790

Extraneous slides

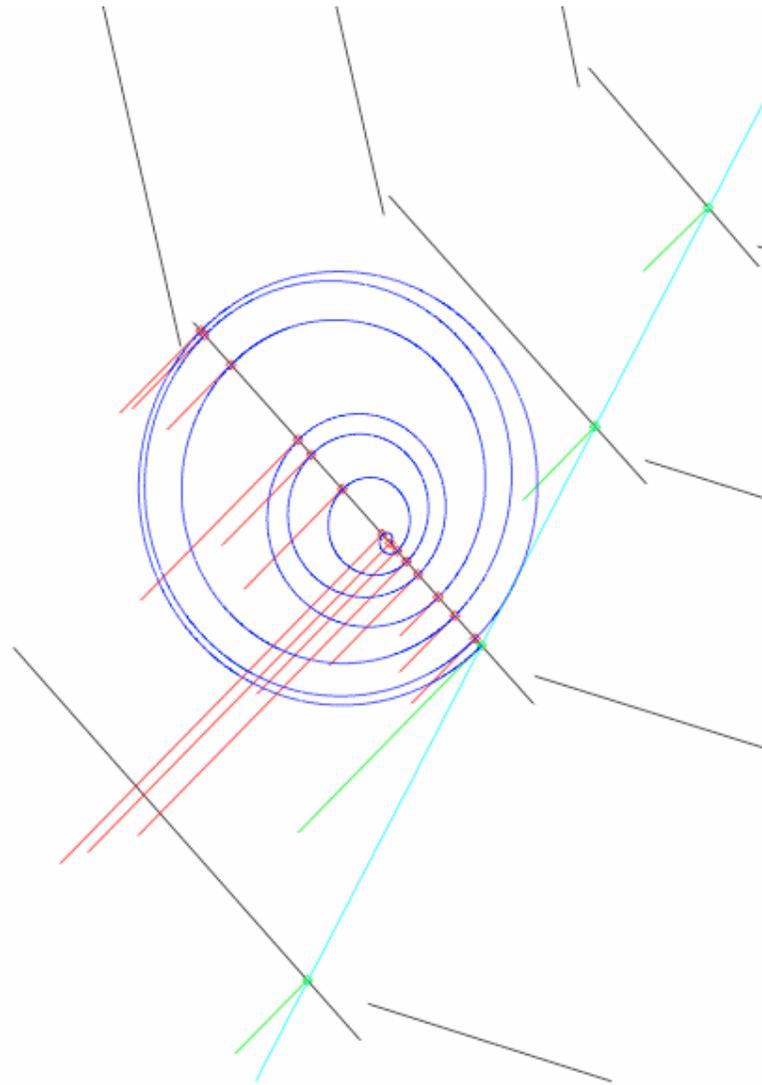
Today's game: What is this?



Today's game: What is this?



Today's game: What is this?



A delta ray kicked off a cosmic muon. Fit for path (explicitly using dE/dx) and get 5.4 MeV.